

# “Silicon-based Photomultipliers” a new generation of photon detector



京都大学

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# Outline

- Introduction
- Operation principle
- Multi-Pixel Photon Counter (MPPC)
  - Performance
  - Future developments
- Summary



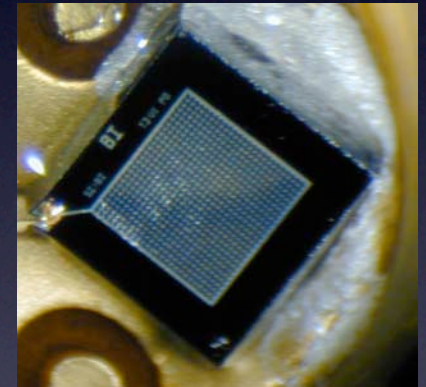


# Introduction

# “Silicon Photo-multiplier”??

- Known in many many names...

- SiPM
- MRS-APD
- SPM
- MPGM APD
- AMPD
- GM-APD
- **MPPC**
- .....



- Reflecting progress in many places in short time.



# R&D over the world



Some maybe missing..





# Why so interesting?

- Many **advantages**:
  - High ( $10^5$ - $10^6$ ) gain with low voltage ( $<100V$ )
  - High photon detection efficiency
  - Compact and robust
  - Insensitive to magnetic fields
- Although as many **possible drawbacks** *at this moment*:
  - Only small size (typically  $\sim\text{mm}^2$ ) available
  - High dark count rate ( $100\text{kHz}$ - $1\text{MHz}/\text{mm}^2$ )
  - Optical cross-talk and after-pulse



# Example of considered applications

- HEP
  - Neutrino detectors
  - ILC calorimeter/muon detectors
  - Aerogel-RICH for super-B, ....
- Astrophysics
  - Air Cherenkov telescopes, ....
- Medical
  - PET, .....

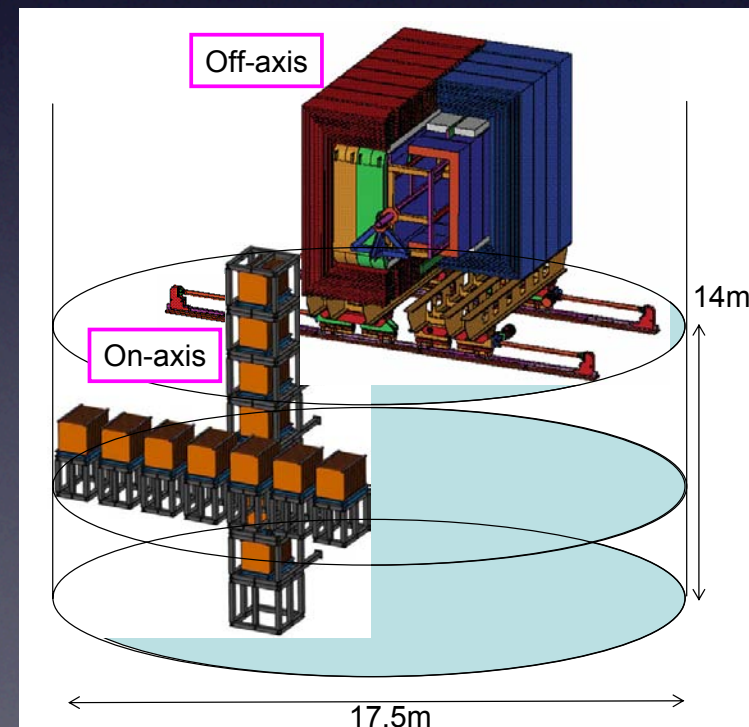
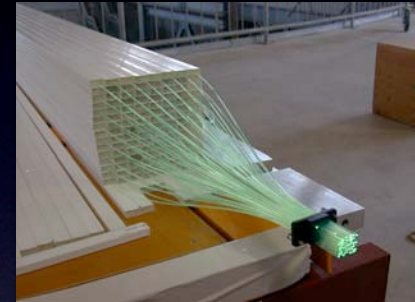




# Example of application: T2K near detectors

(Long baseline  $\nu$  oscillation experiment from 2009)

- Measure  $\nu$  properties just after production
- Most of sub-detectors will use plastic scintillators + wavelength-shifting fibers
- Some placed inside magnetic field
- Severe constraint on available space
- Chosen MPPC (Hamamatsu device) as the photo-sensor
  - ~60,000 channels in total
  - First use in large-scale real exp.

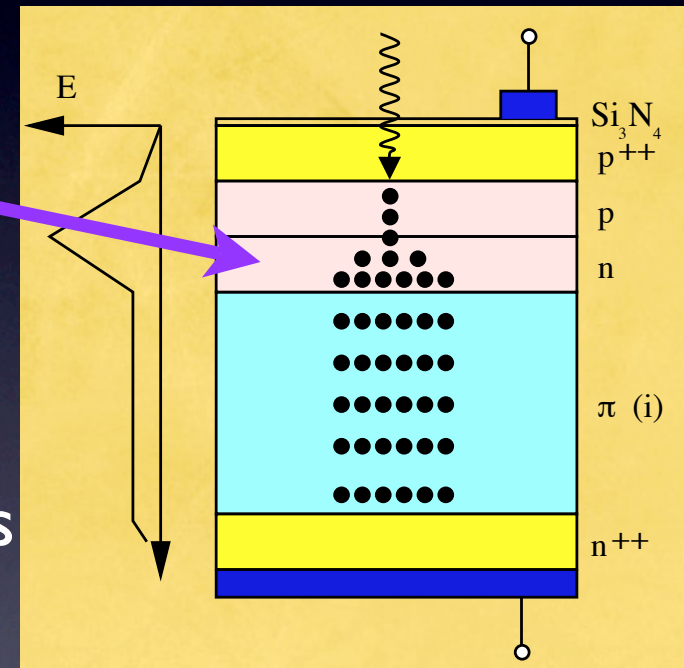




# Operation principles

# Avalanche Photodiodes (APDs)

- Photon creates e-h pair near surface
- **Avalanche amplification** in reverse-biased region
- **Linear operation** below **breakdown voltage ( $V_{bd}$ )**:  
output charge  $\propto$  number of e-h pairs  
pairs  $\propto$  number of incident photons
- Typical internal gain: 10-100  
( $\sim 1000$  some case)

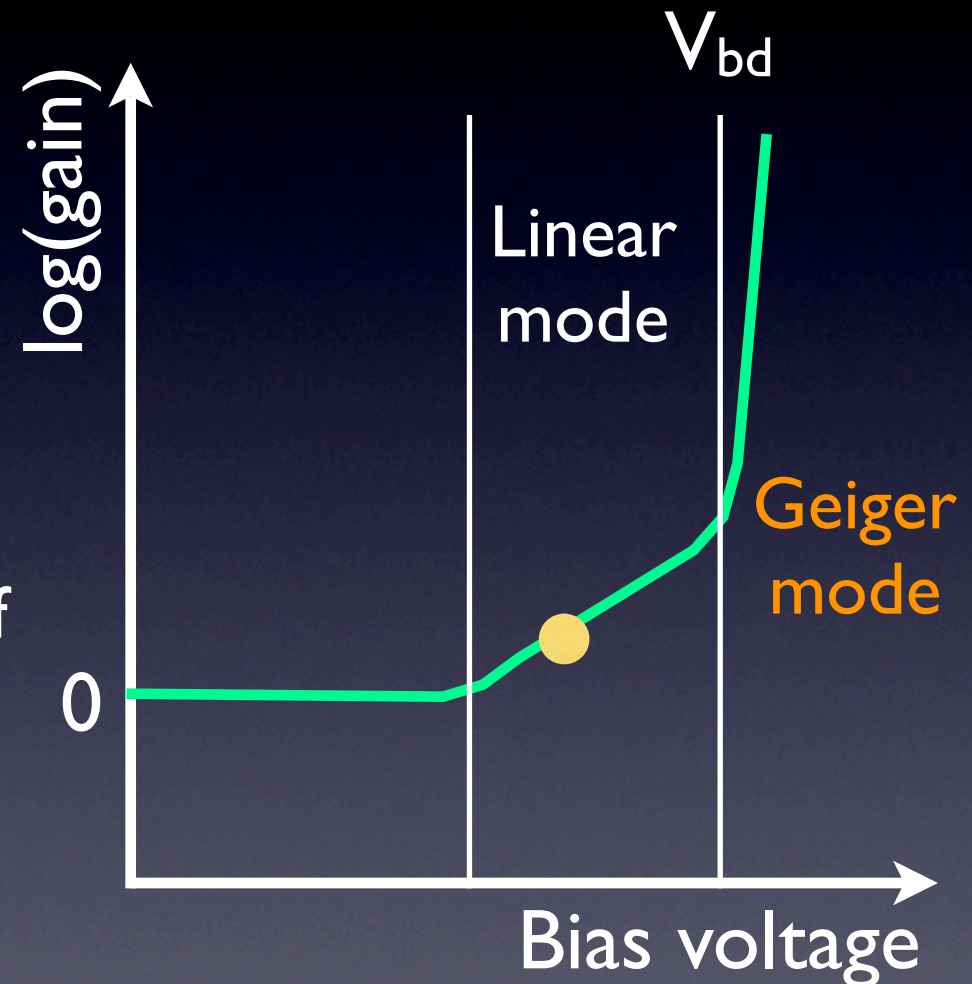


Schematics of APD  
for CMS-ECAL



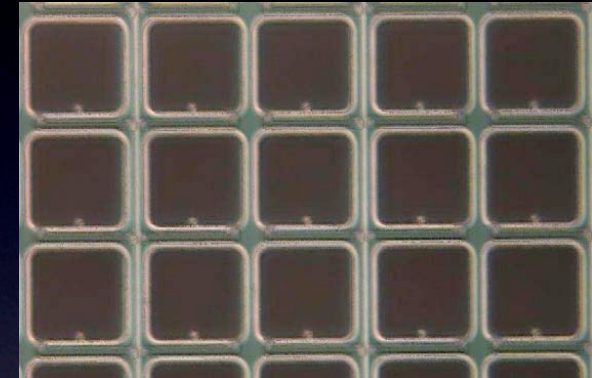
# Geiger-mode operation of APDs

- Operation **above the breakdown voltage**
- **High internal gain**
- **Binary device**
  - Same amount of charge regardless of number of incident photons
- Discharge may be 'quenched' by external register

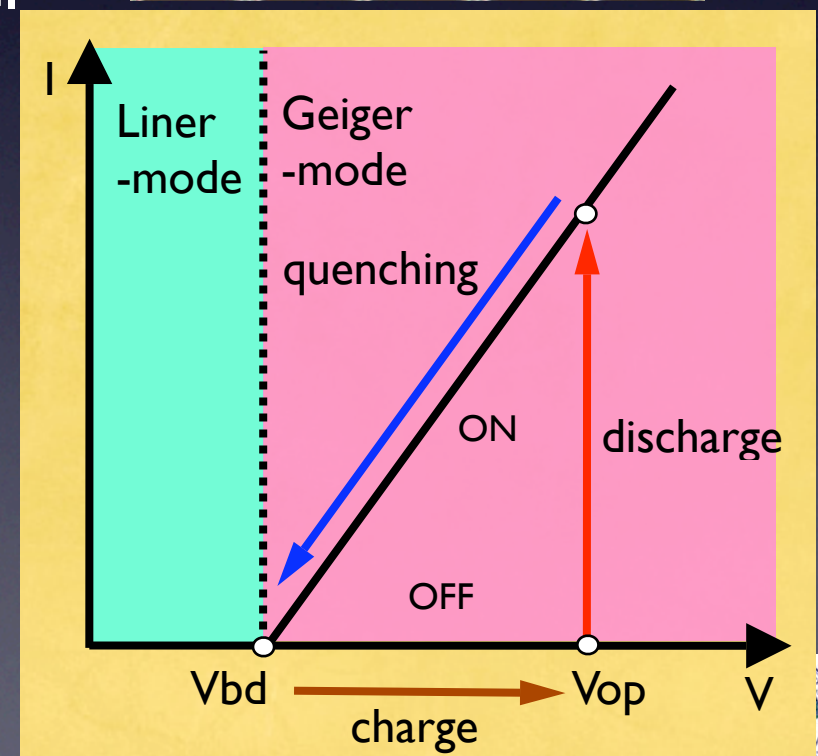


# Counting Photons with Geiger-mode APDs

20-100 $\mu$ m



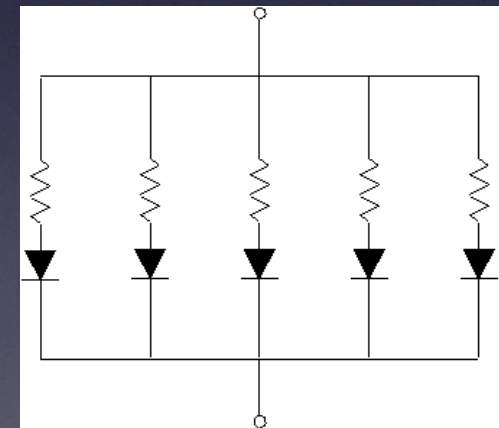
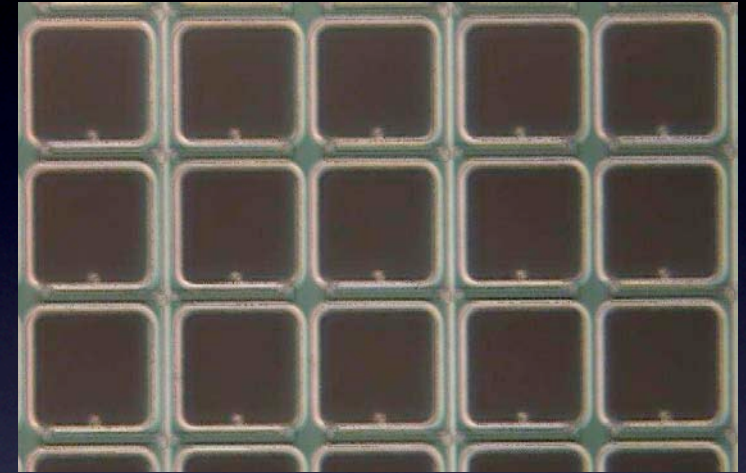
- Divide APD into many small pixels.
- Each pixel works **independently in Geiger mode**
- Incident photon 'fires' an APD pixel *but not others*
- Output charge from one pixel:  
 $Q_{\text{pixel}} = C_{\text{pixel}} \cdot (V_{\text{op}} - V_{\text{bd}})$
- $C_{\text{pixel}} \sim 10\text{-}100\text{fF}$  and  $\Delta V \equiv V_{\text{op}} - V_{\text{bd}} \sim 1\text{-}2\text{V}$  gives  
 $Q_{\text{pixel}} \sim 10^5\text{-}10^6 e$



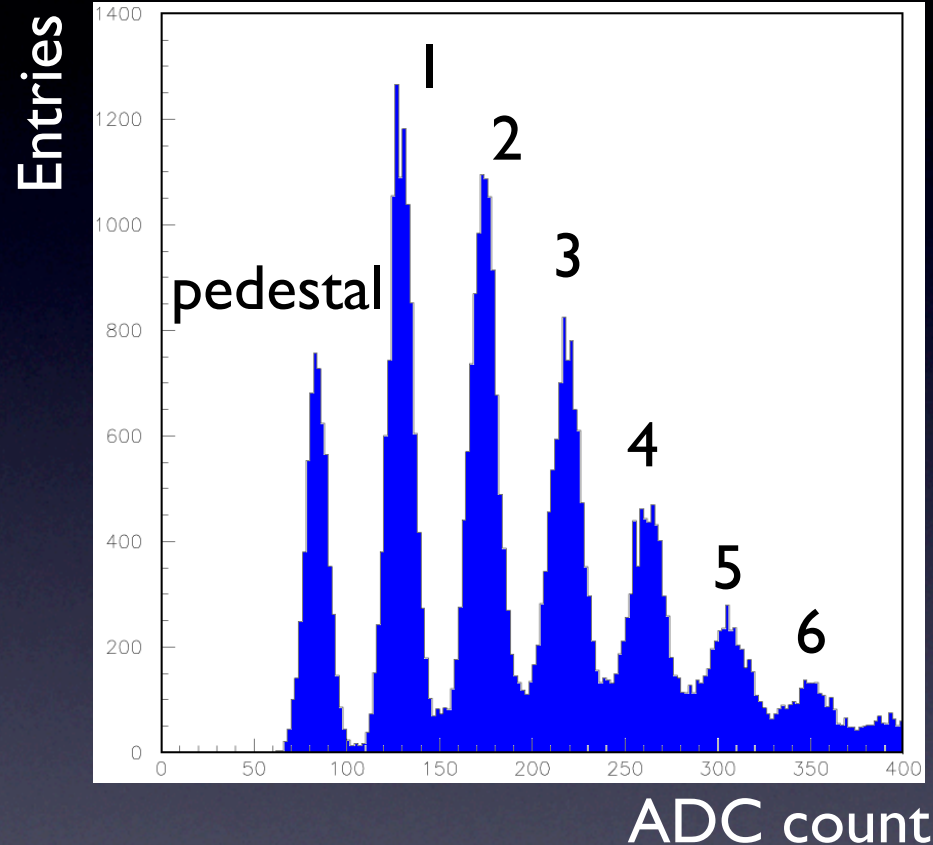
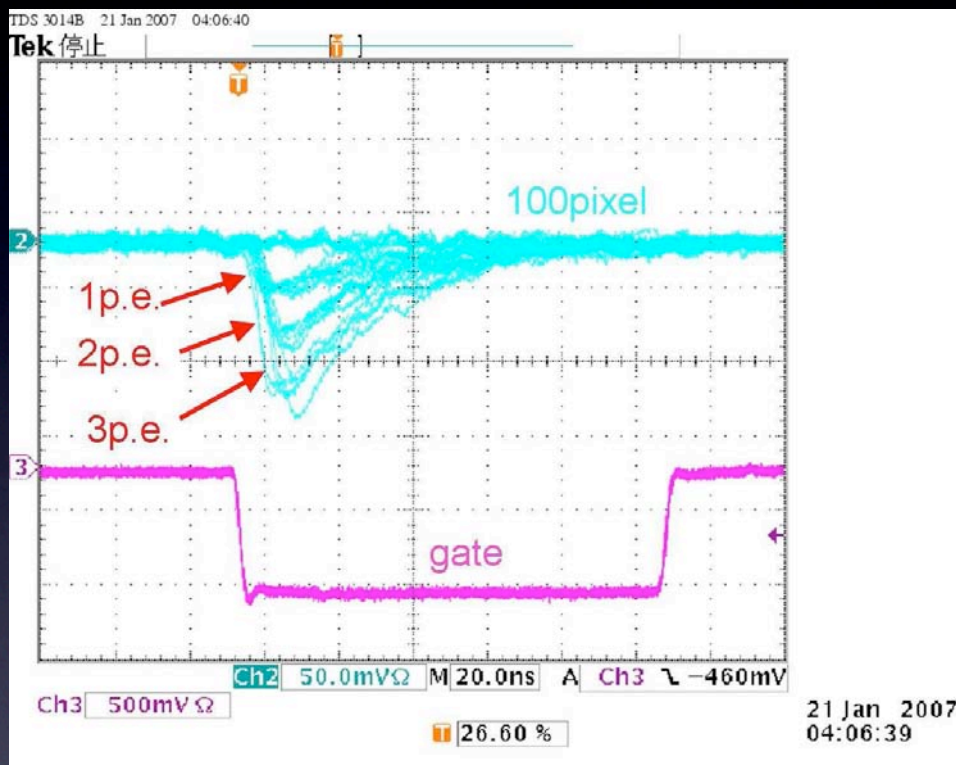


# Operation of Multi-pixel Geiger-mode APDs

- All the pixels are connected *in parallel*
- Taking sum of all pixels, one can know **how many pixels** are fired  $\propto$  **how many photons** are incident !
- $Q = \sum Q_{\text{pixel}} = N \cdot Q_{\text{pixel}}$



# Output from Multi-pixel Geiger-mode APD



**Clear separation of  
1,2,3... photoelectron (p.e.) peaks!**

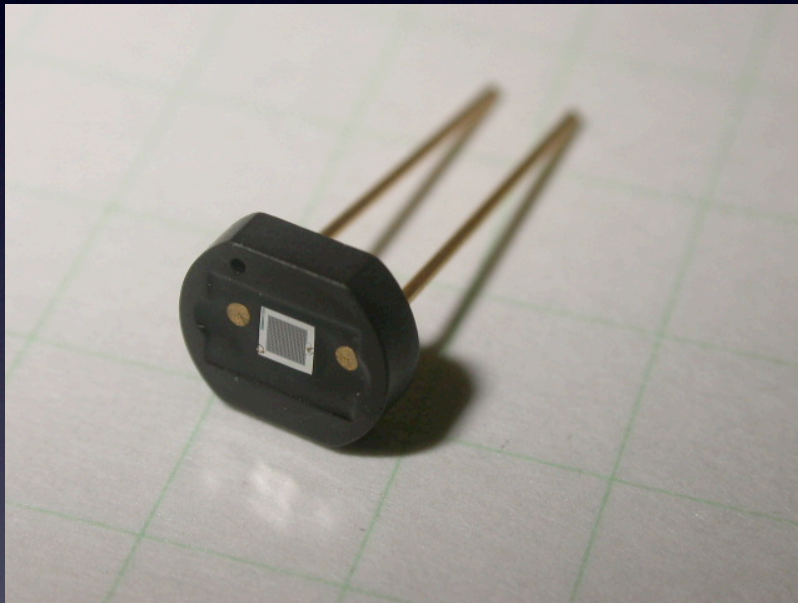
**[@ room temperature]**



# Comparison of photo-sensors

	PMT	APD	'SiPM'
Gain	$10^6-10^7$	$\sim 100$	$10^5-10^6$
Operation voltage(V)	1-2k	300-500	$< 100$
Active area	$\sim > 100\text{cm}^2$	$\sim 10\text{mm}^2$	$\sim 1\text{mm}^2$
Dark count (Hz)	$< 1\text{k}$		0.1-1M
Photon detection efficiency (blue-green)	$\sim 15\%$	75-80%	20-50%
Magnetic field	x	o	o

# Multi-Pixel Photon Counters (MPPC)



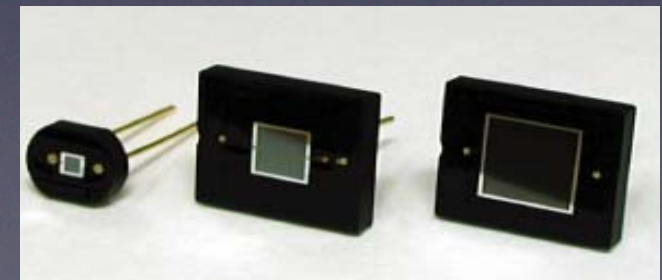
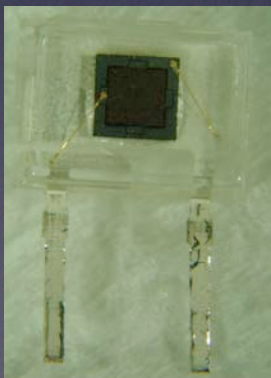
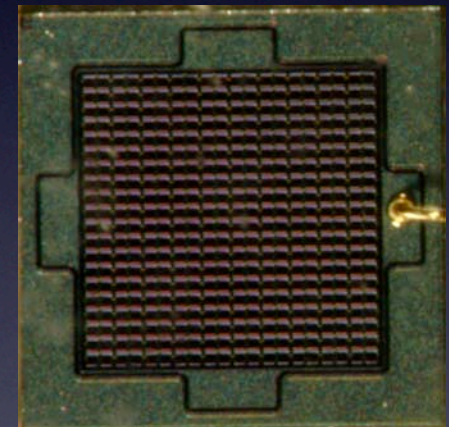
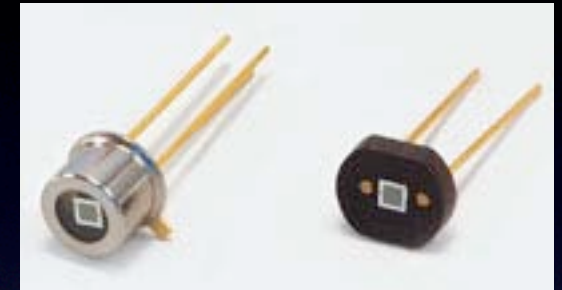
Menlo Park Presbyterian Church →  
[www.mppc.org](http://www.mppc.org)





# MPPC by Hamamatsu

- Structure based on CMS-APD
- Currently on catalogue:
  - $1 \times 1 \text{ mm}^2$  active area
  - 100/50/25  $\mu\text{m}$  pixel pitch
  - Metal or ceramic package
- In future..
  - Larger area:  $3 \times 3 \text{ mm}^2$  ( $5 \times 5 \text{ mm}^2$ )
  - Larger pixel pitch
  - More variations of package



# Spec by Hamamatsu

■ Electrical and optical characteristic (Ta = 25°C)

Parameter		1600	400	100	Unit
Chip size		1.5 x 1.5			mm
Effective active area		1 x 1			mm
Number of pixels		1600	400	100	-
Pixel size		25 x 25	50 x 50	100 x 100	um
Geometric efficiency		30.8	61.5	78.5	%
Sensitivity	$\lambda = \lambda_p$	400			nm
	Quantum efficiency	70 min.			%
	PDE	25	50	65	%
Operating voltage		77±10	70±10	70±10	V
Gain		2.75E+05	7.50E+05	2.40E+06	-
Dark count		100	270	400	Kcps
Terminal capacitance		35			pF
Time resolution (FWHM)		250	220	250	ps
Temp coefficient of bias voltage		50			mV/°C

The last letter of each product number indicates which type of package is used. (U : Can , C : Ceramic)

1: The figures in PDE (Photon Detection Efficiency) include cross-talk and after pulse.





# Performance of MPPC

for 50 $\mu$ m pitch device, unless noted

# Key performance (I)

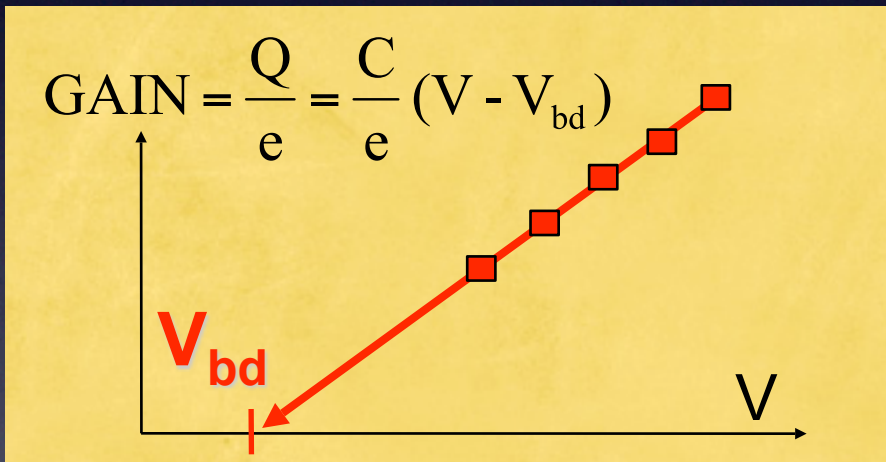
- Basic parameters
  - Gain
  - Noise
  - Photon detection efficiency
  - Timing resolution



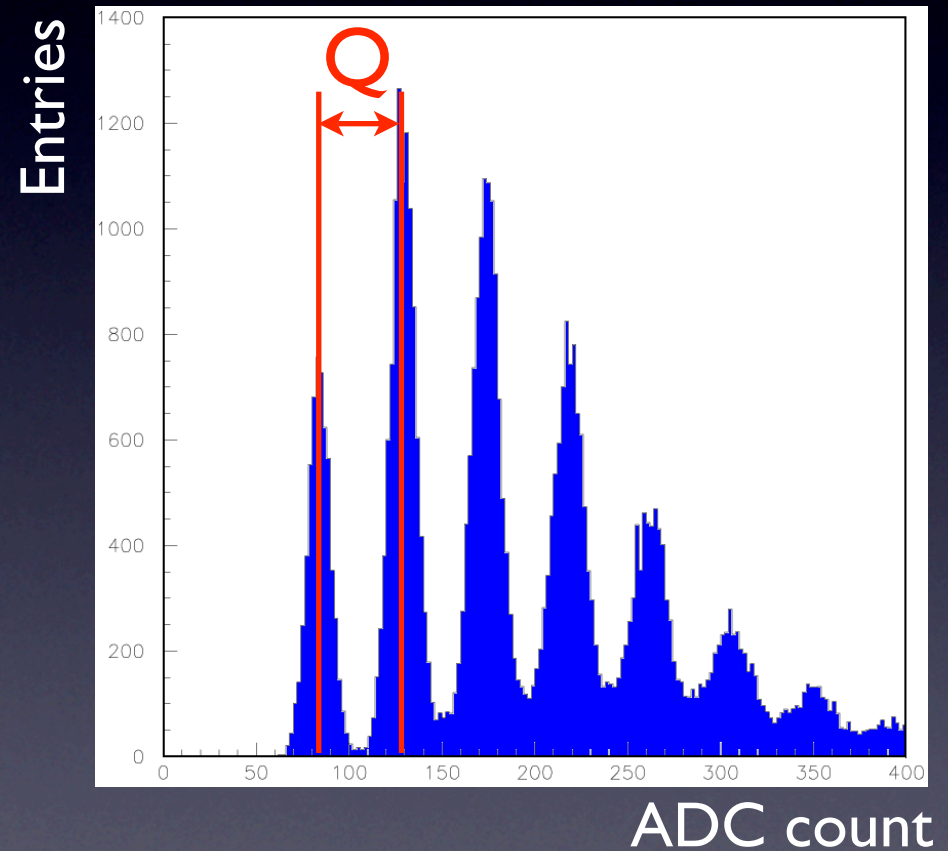


# Gain & $V_{bd}$

- Gain of MPPC can be measured with well-separated p.e. peaks:  
Gain =  $Q/e$



- Using linear relation, breakdown voltage ( $V_{bd}$ ) also derived

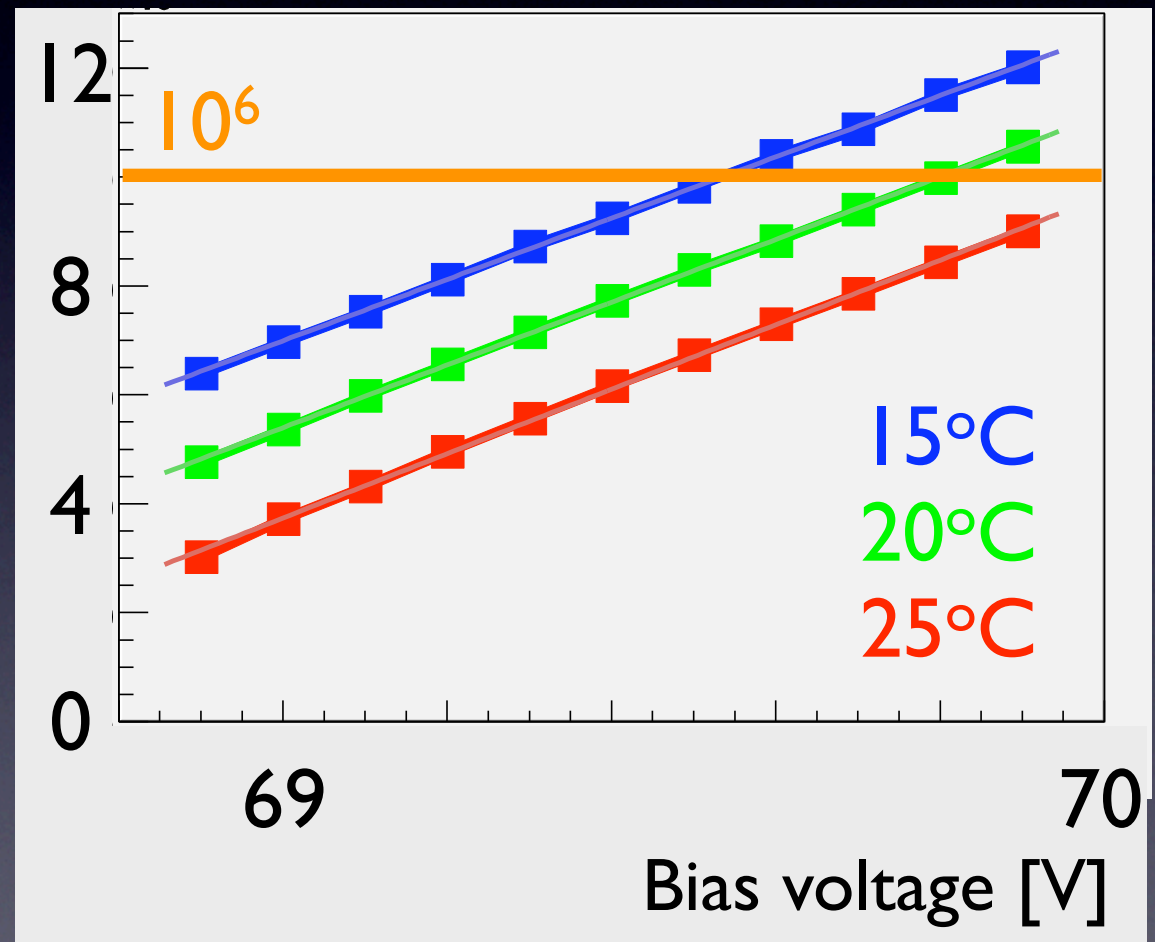


# Measured gain

- MPPC has  $\sim 10^6$  internal gain.

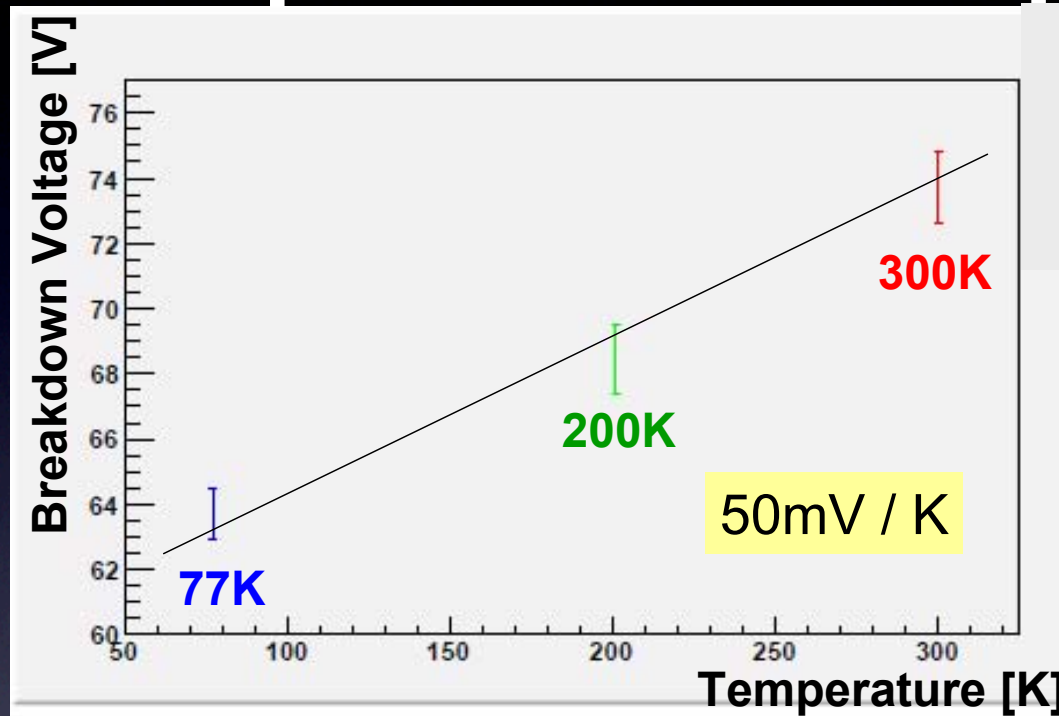
HPK spec is  $7.5 \times 10^5$   
( $\Delta V \sim 1.3V$ )

Gain ( $10^5$ )





# Temperature dependence



H. Otono

@PD07

1600 pixel

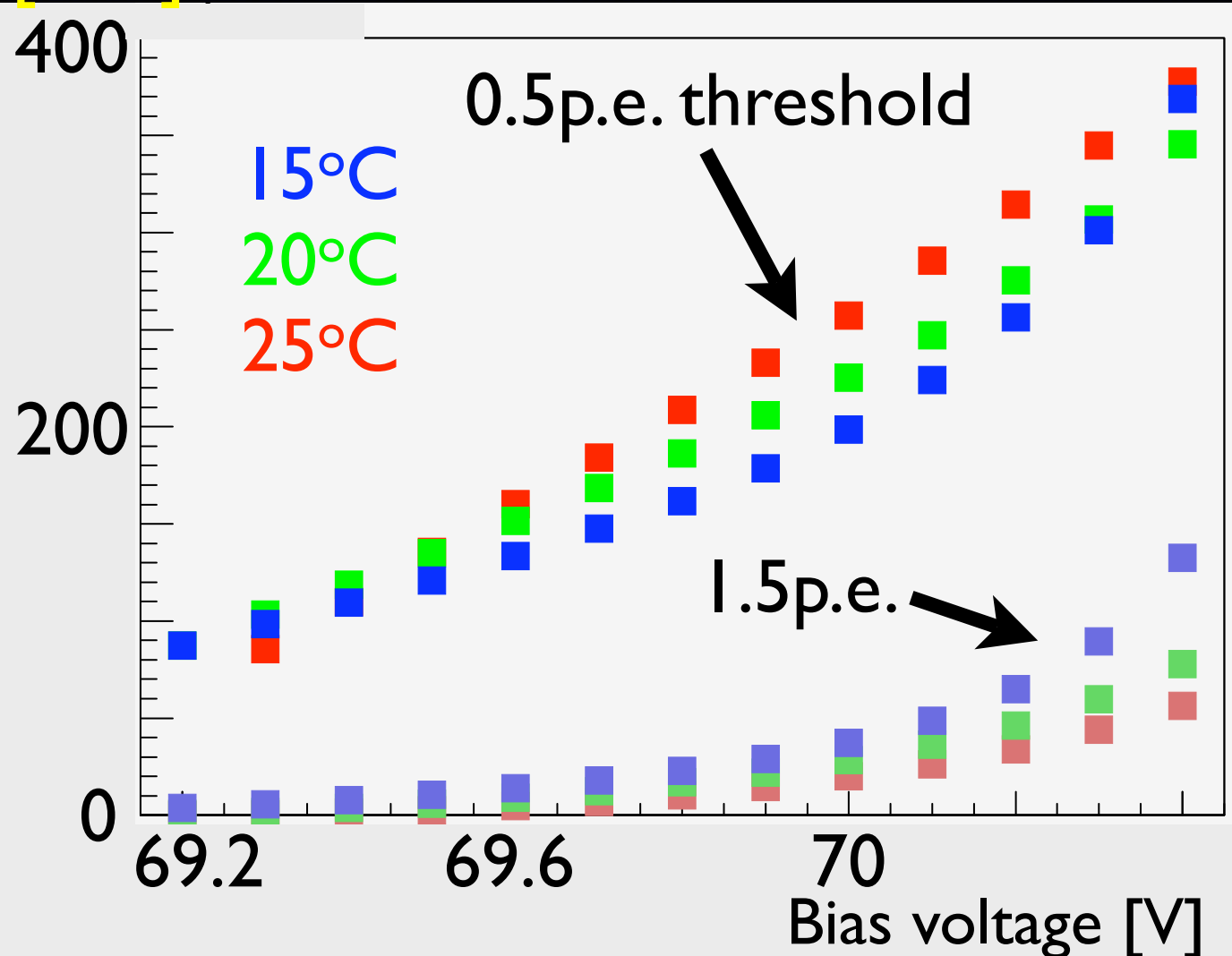
(Also many measurements around room temperature)

- Many parameters of MPPC are known to depend on 'over-voltage'  $\Delta V \equiv V - V_{bd}$
- $V_{bd}$  linearly depends on temperature  $dV_{bd}/dT \sim -50\text{mV/K}$

# Dark noise rate

- Measured with scaler
  - 1 p.e. noise dominates
- ~ order lower than other 'SiPM' type devices

[kHz]



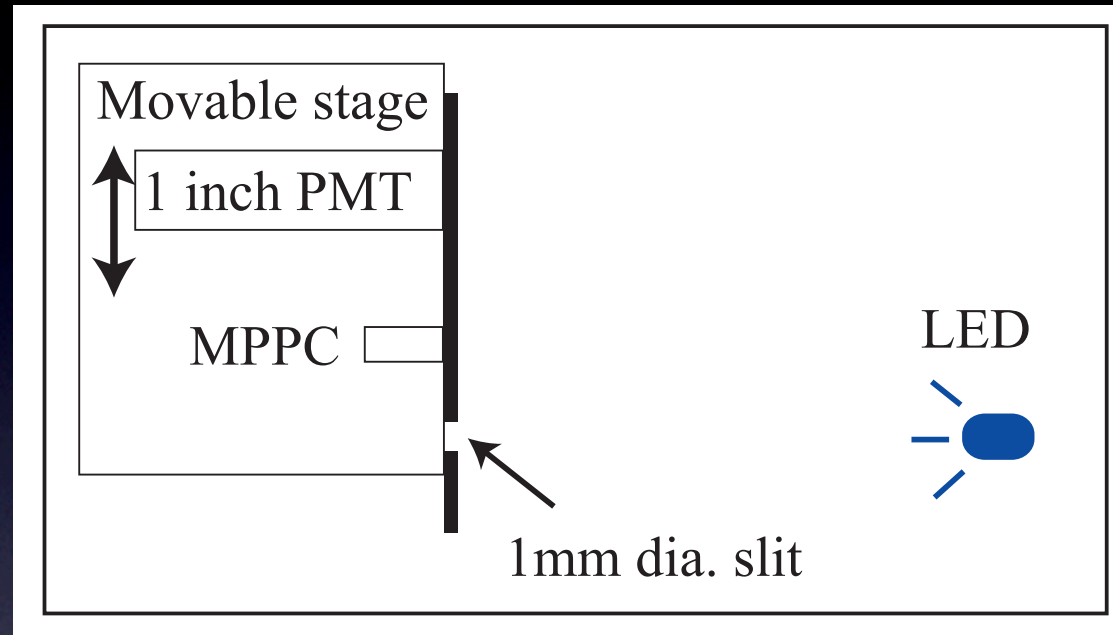


# Photon Detection Efficiency (PDE)

- Probability of detecting single photon entering the surface of device
- Three major components:
  - Geometrical efficiency  
(30/60/78% for 25/50/100 $\mu\text{m}$  pixels)
  - Quantum efficiency
  - Probability to trigger Geiger avalanche
    - Depends on over-voltage.



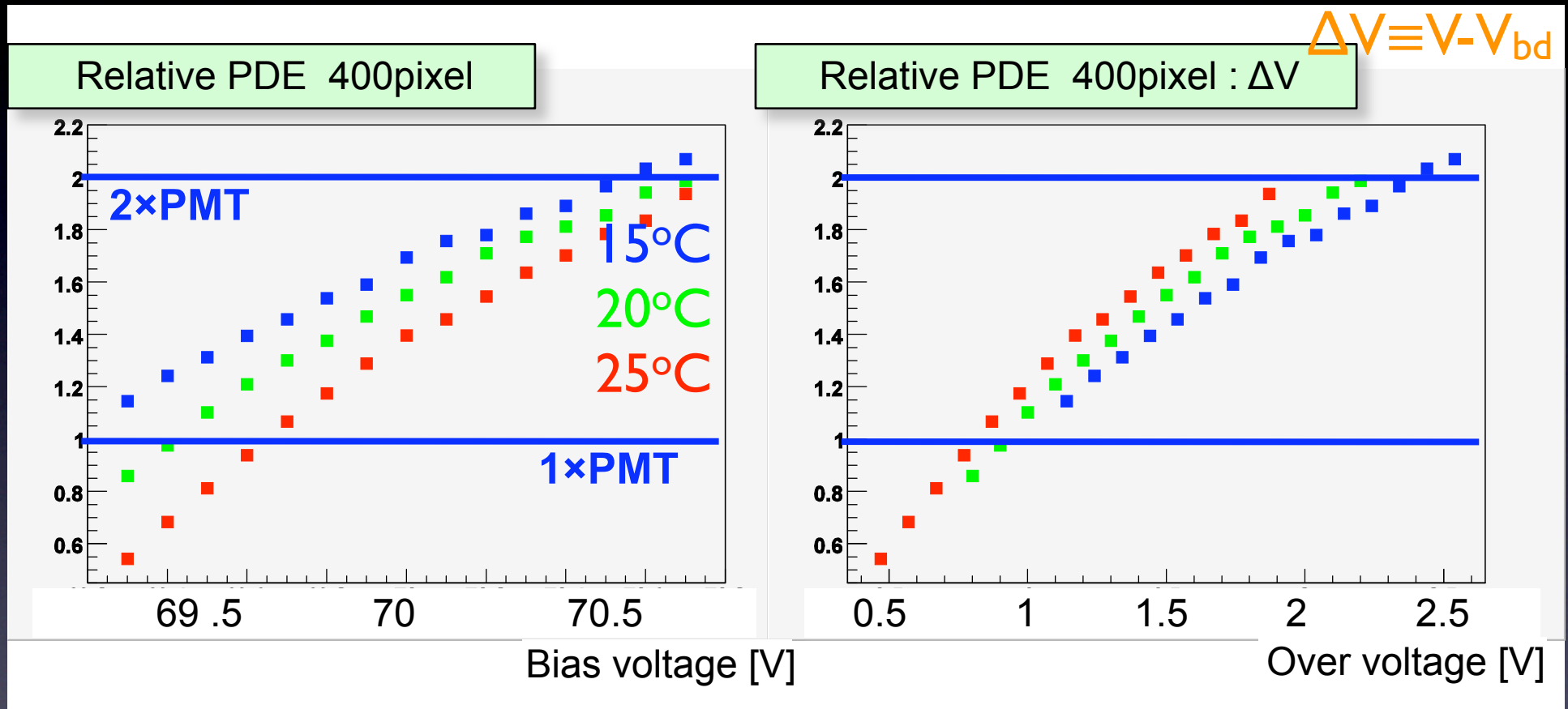
# Photon Detection Efficiency



- Measured using PMT (bialkali, QE~15% by catalogue) as reference
- Compare detected number of p.e.
- Light source: Blue LED (Nichia NSPB500S, peak  $\lambda \sim 470\text{nm}$ )



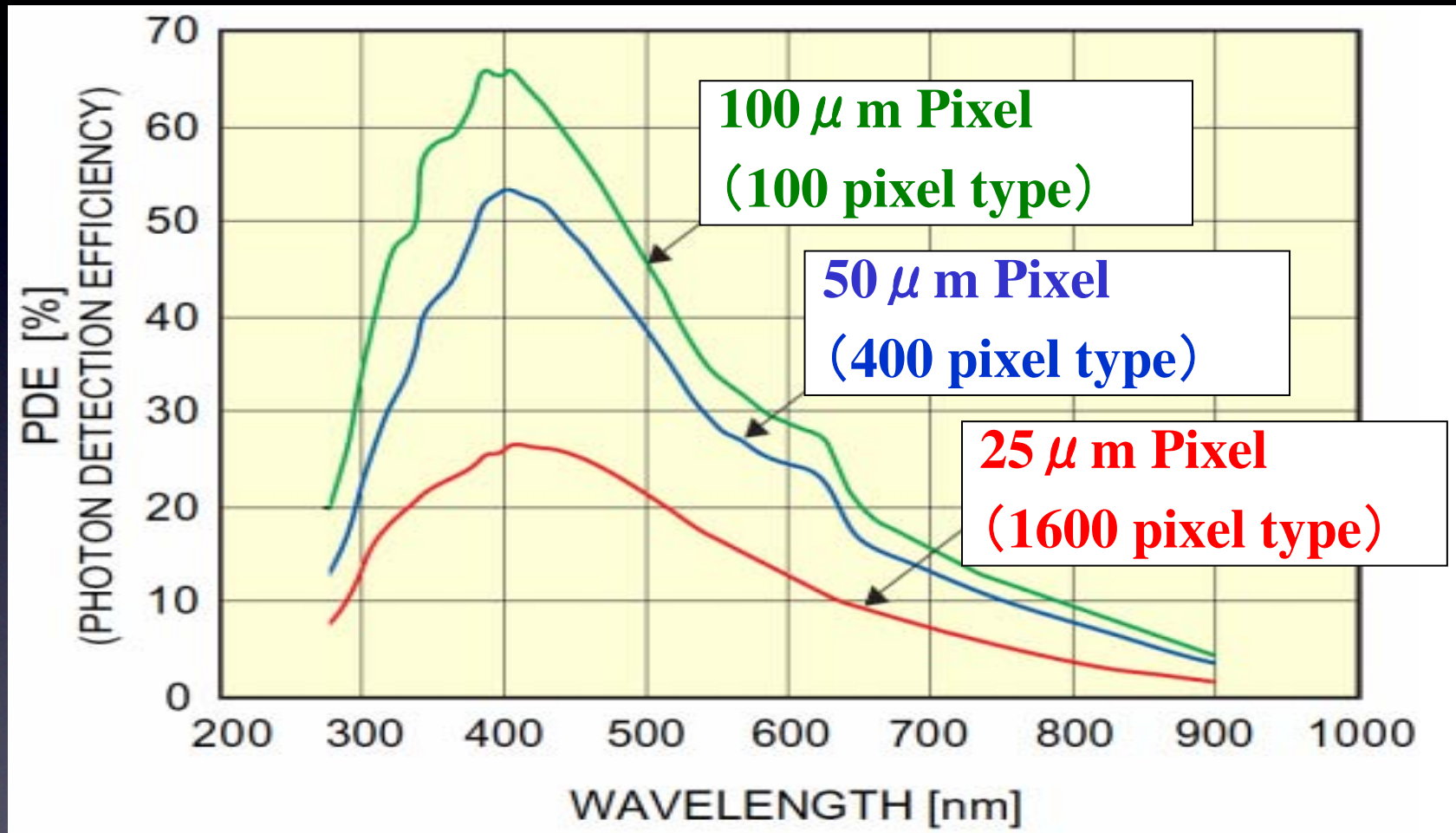
# Photon Detection Efficiency



- PDE for MPPC is higher than PMT.

\*p.e. for MPPC derived from pedestal fraction to avoid cross-talk and after-pulse effects.

# PDE from catalogue



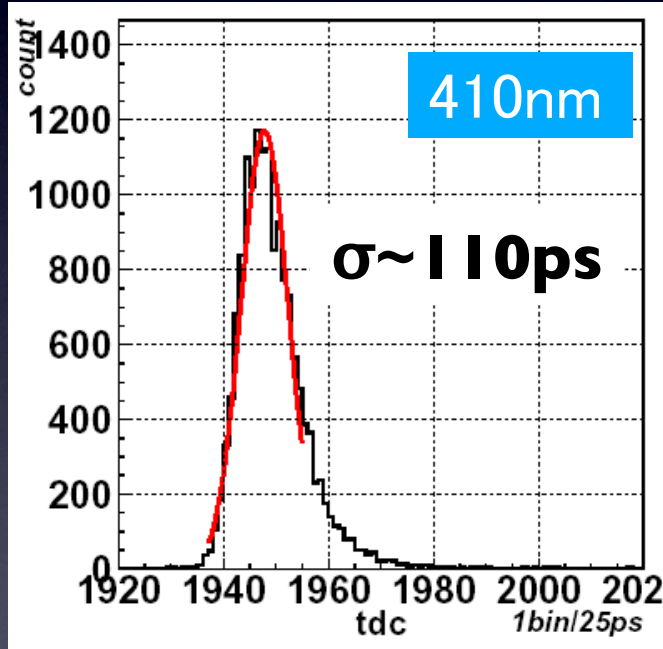
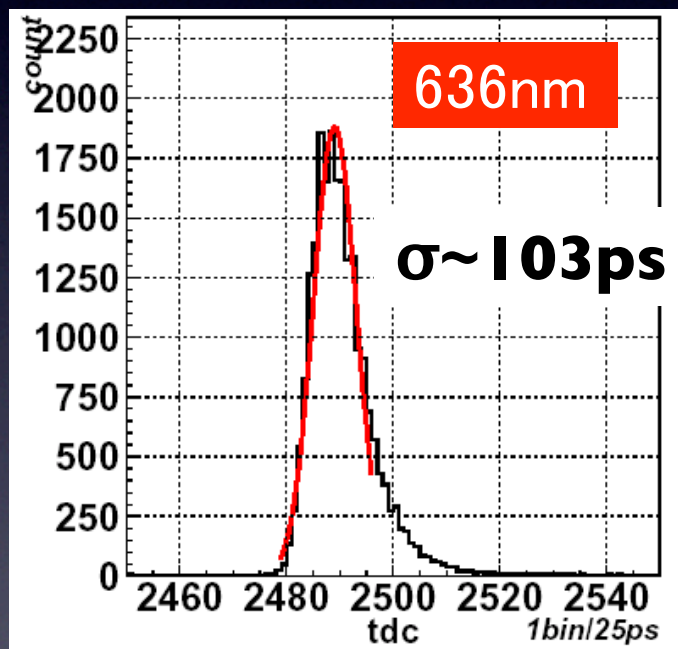
\* Measured with current:  
includes effects from cross-talk and after-pulse.



# Timing resolution

Measured w/ pulse laser  
636 / 410nm

Sample MPPC  
Bias -71.5V  
Threshold 0.5pe  
Only Single photon data



Time walk  
corrected.

T. Iijima @PD07

# Key performance (2)

- Parameters under intensive study.
  - Optical cross-talk
  - After-pulse
  - Radiation effects





# Optical cross-talk

- Photons created during avalanche can enter neighboring pixels
- They can trigger additional avalanche → **optical cross-talk**
- Increase excess noise factor



# After-pulse

- Carrier trapped in impurity state may be released after certain time and cause delayed avalanche in the same pixel, or **after-pulse**
- Also increase excess-noise factor





# Measurement of cross-talk and after-pulse

Charge (ADC) distribution

Fraction of pedestal events

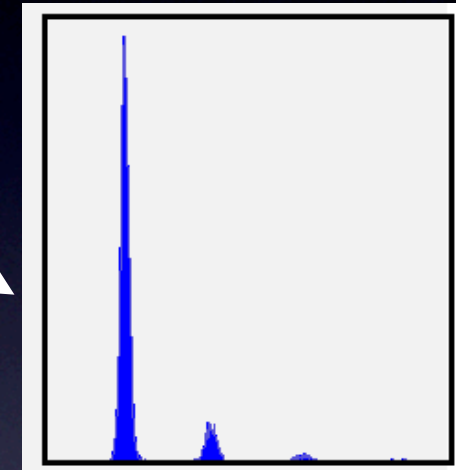
Poisson statistics

Estimate 'true'  
I p.e. events

Comparison

Observed  
I p.e. events

Probability of cross-talk&after-pulse

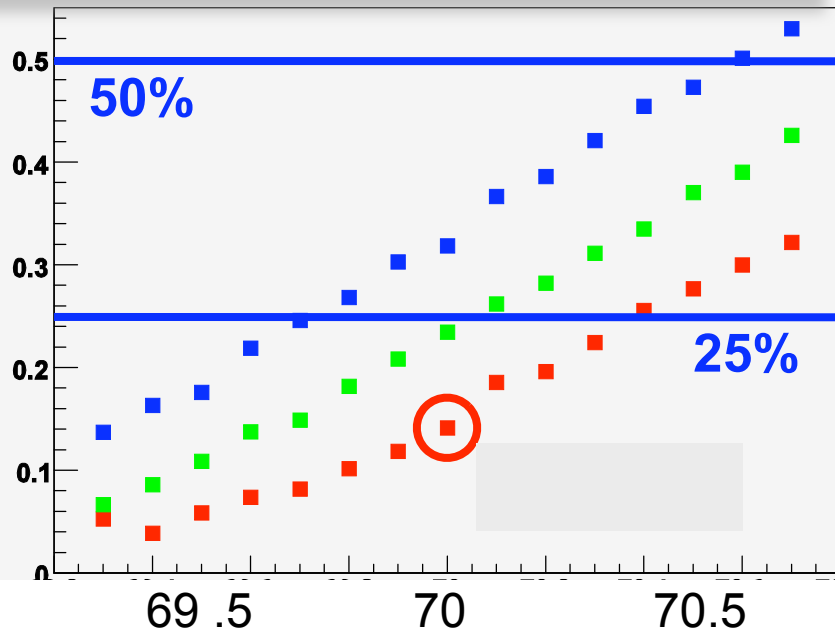


\*Only combined probability can be measured with this technique.

# Cross-talk & after-pulse

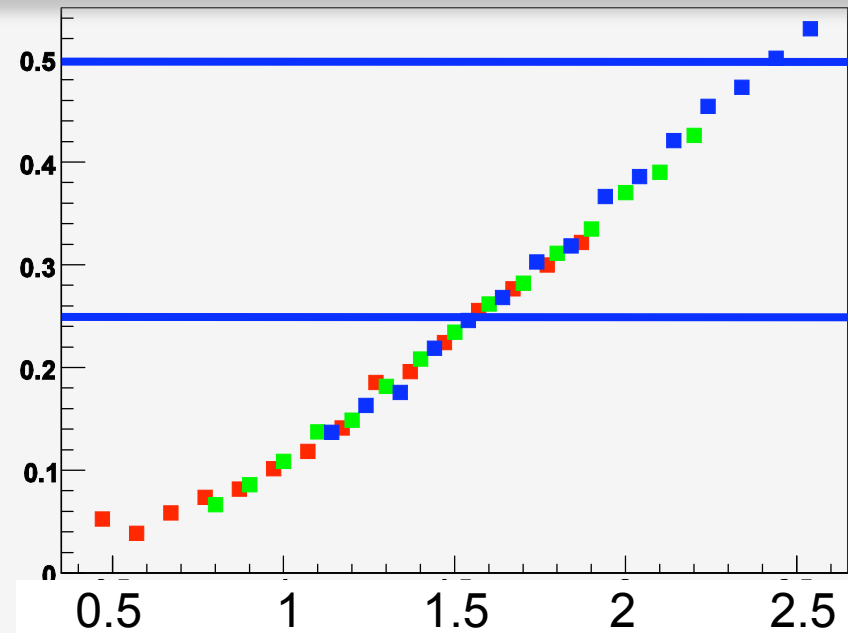
Gate width: 800ns

Cross-talk & after pulse rate 400pixel



Bias voltage [V]

Cross-talk & after pulse rate 400pixel :  $\Delta V$



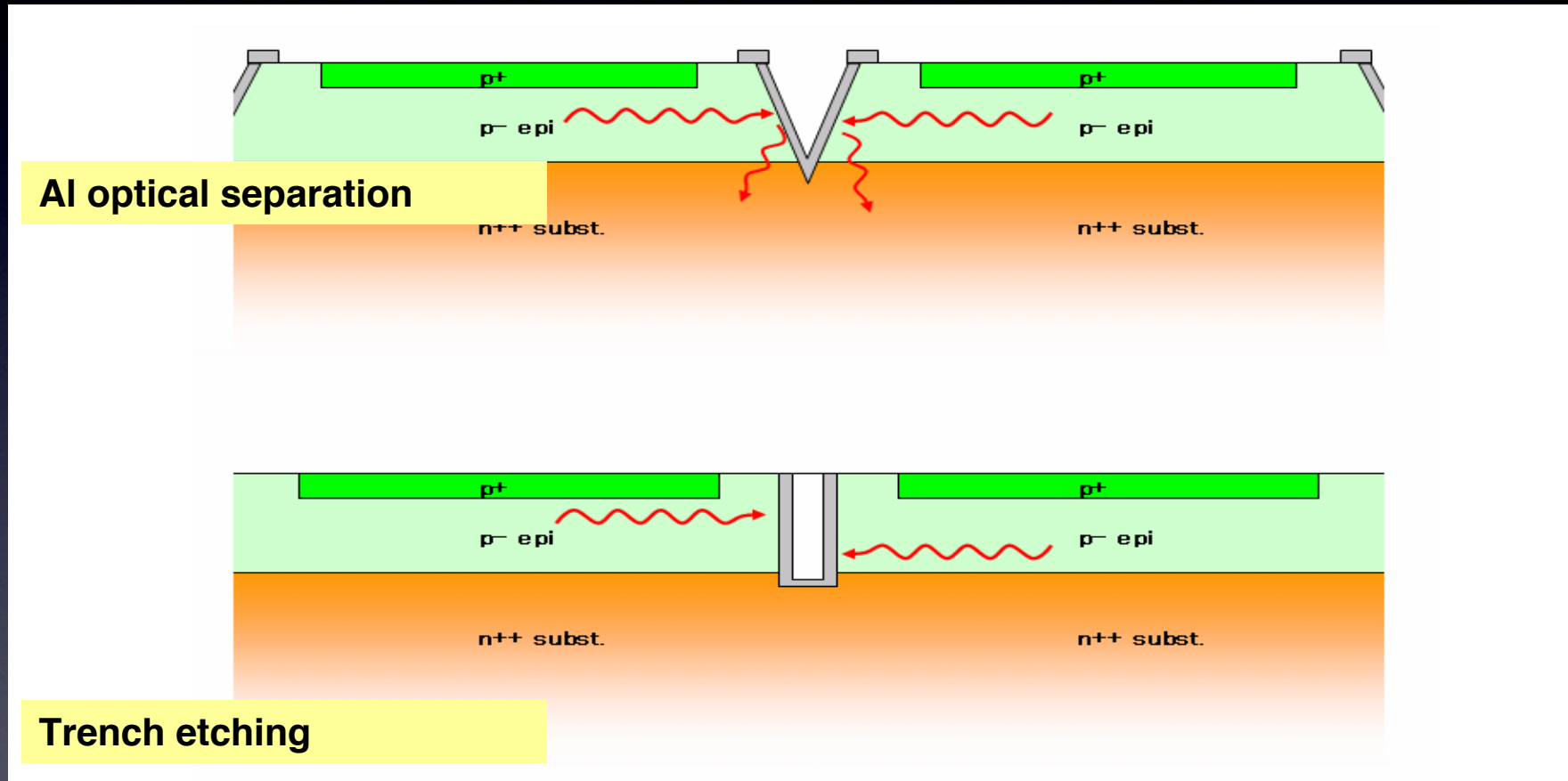
Over voltage [V]

Significant effect observed.  
Depends on over-voltage.

S. Gomi  
(Kyoto)



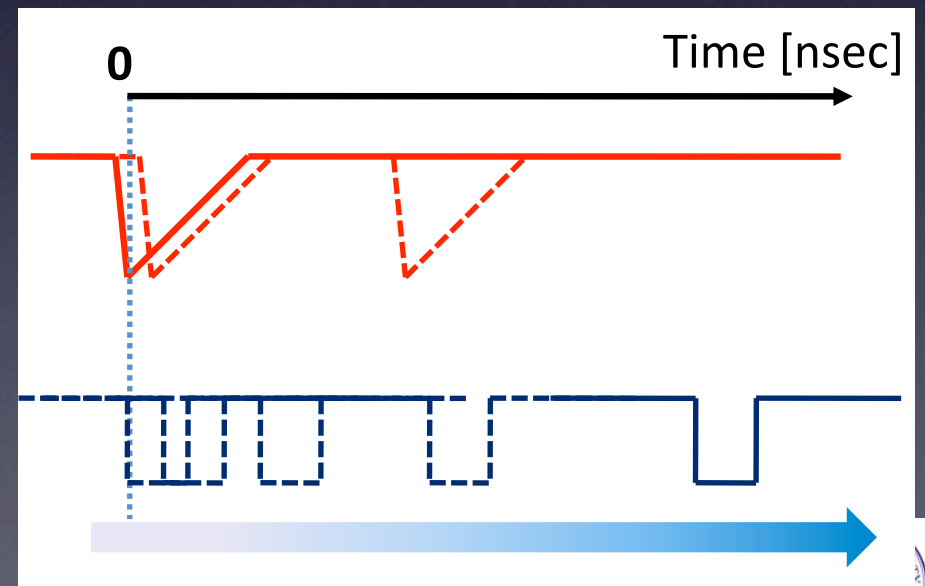
# Possibility of cross-talk suppression



K.Yamamoto @ PD07

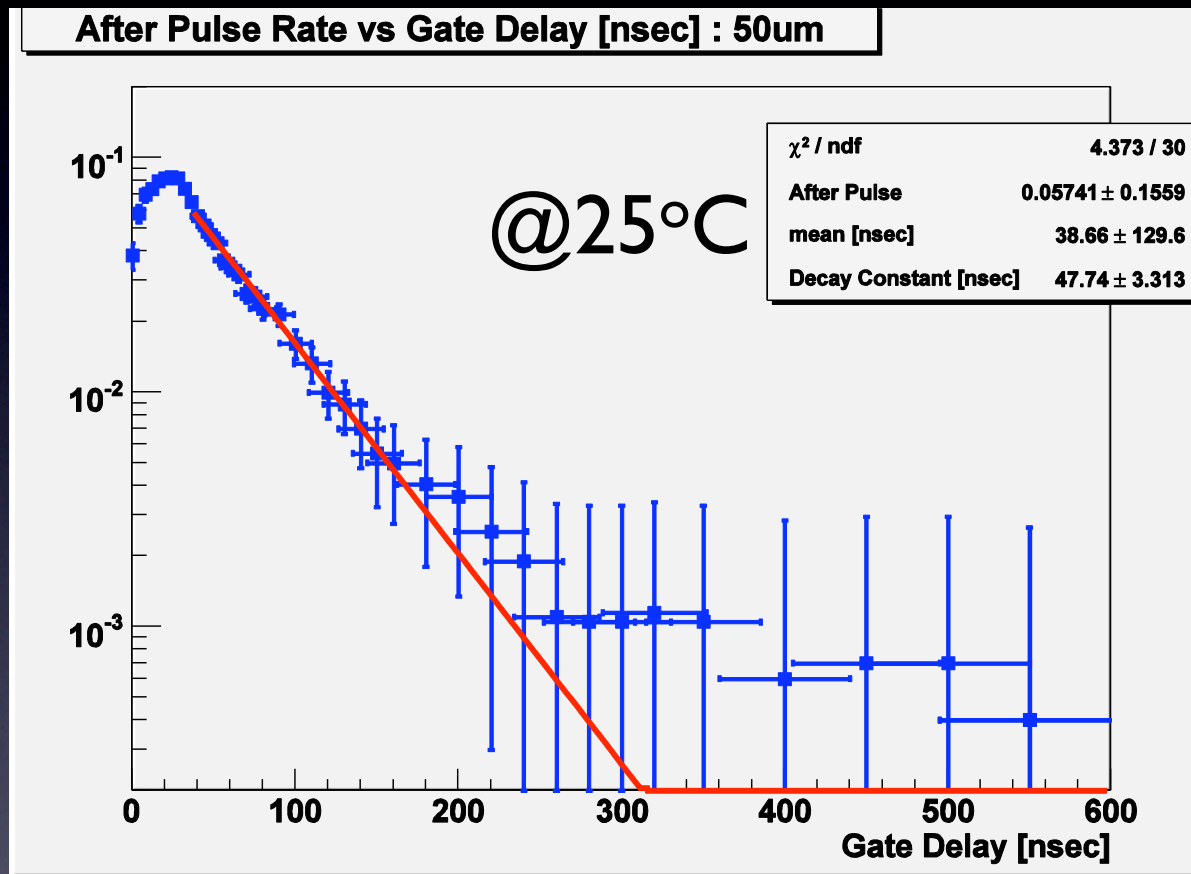
# Study of after-pulse

- Special structure with only one pixel
  - No cross-talk effect
  - Pixel structure identical to usual ones
- Using delayed gate with self-trigger, measure time constant of after-pulse





# Measured time constant



S. Gomi  
(Kyoto)

- ~50ns for 50 $\mu$ m pixel (~150ns for 100 $\mu$ m)  
More study in near future.

# Radiation effects

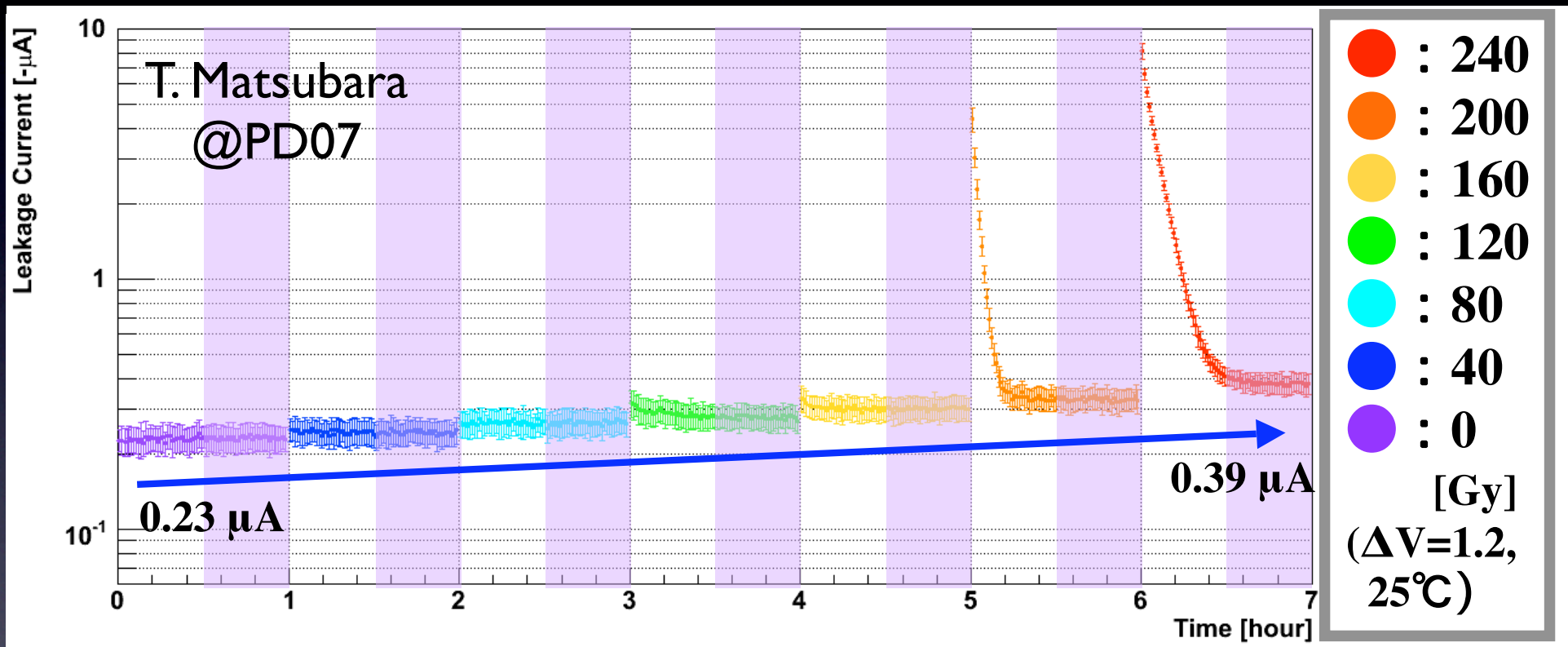
- Several studies in Japan:
  - $\gamma$ -ray irradiation with  $^{60}\text{Co}$
  - Proton irradiation at RCNP 53.3MeV cyclotron
  - Neutron irradiation at reactor (ongoing, not reported here)





# $\gamma$ -ray irradiation

$^{60}\text{Co}$

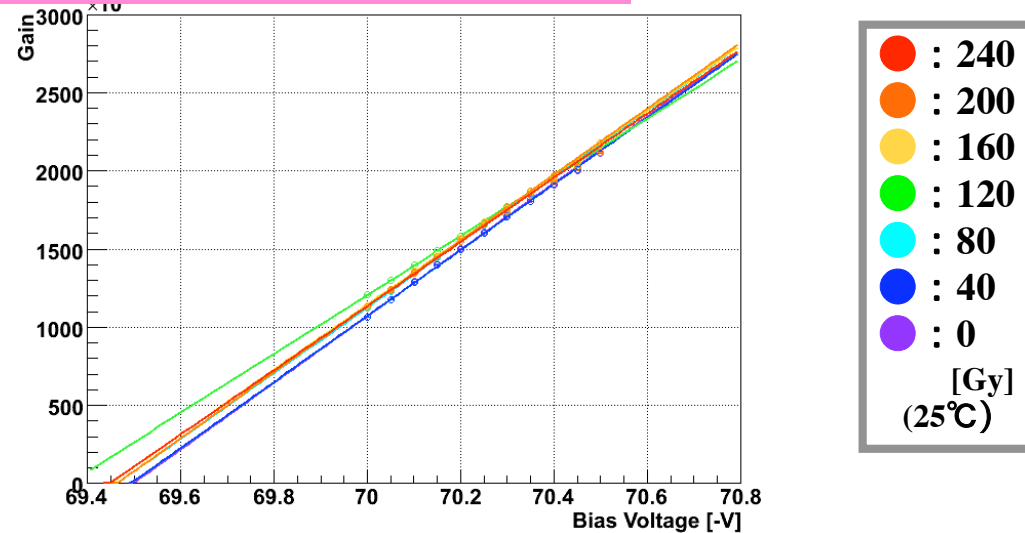


- Leakage current after every 40Gy irradiation
- Annealing observed

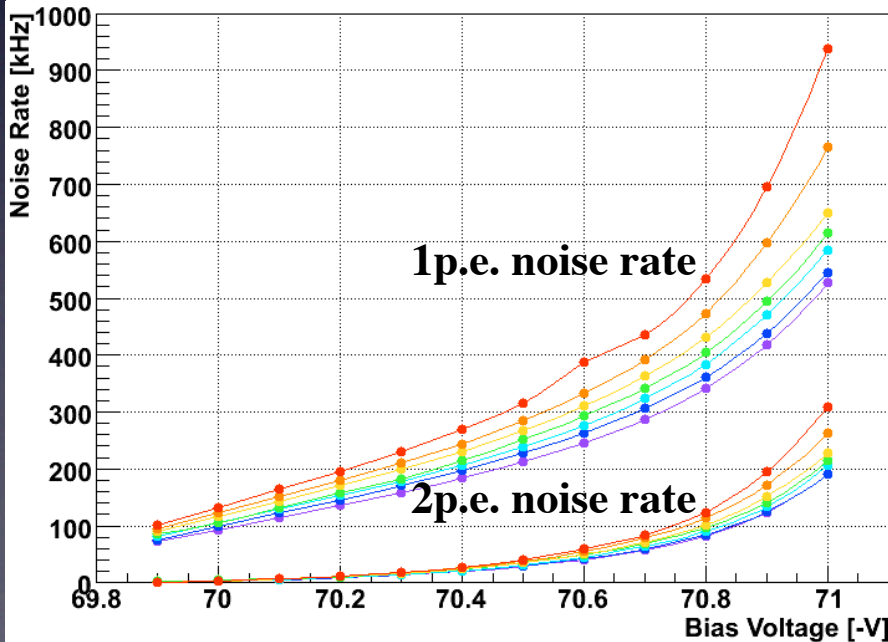
# γ-ray irradiation

T. Matsubara  
@PD07

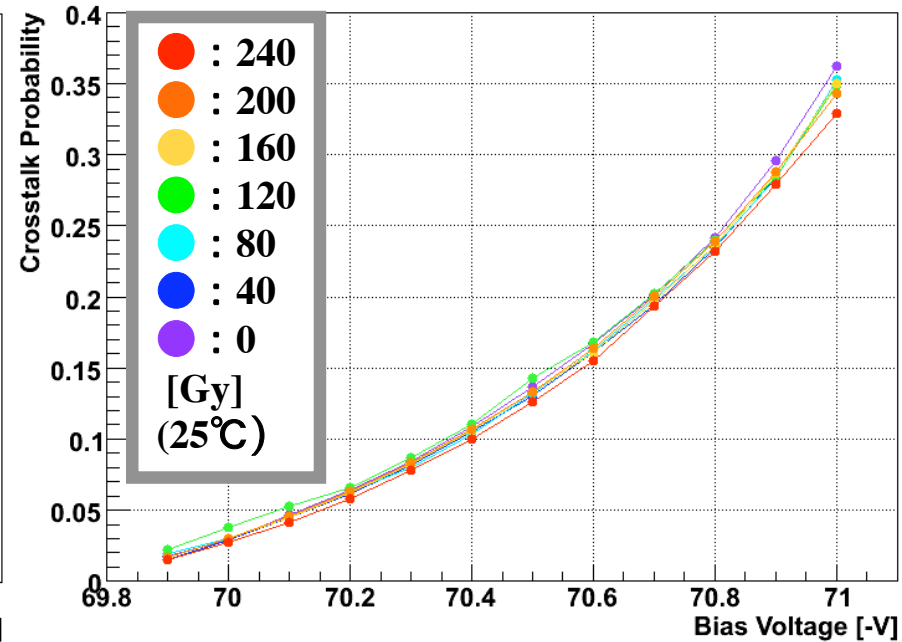
## Gain vs Bias voltage



## Noise rate vs Bias voltage

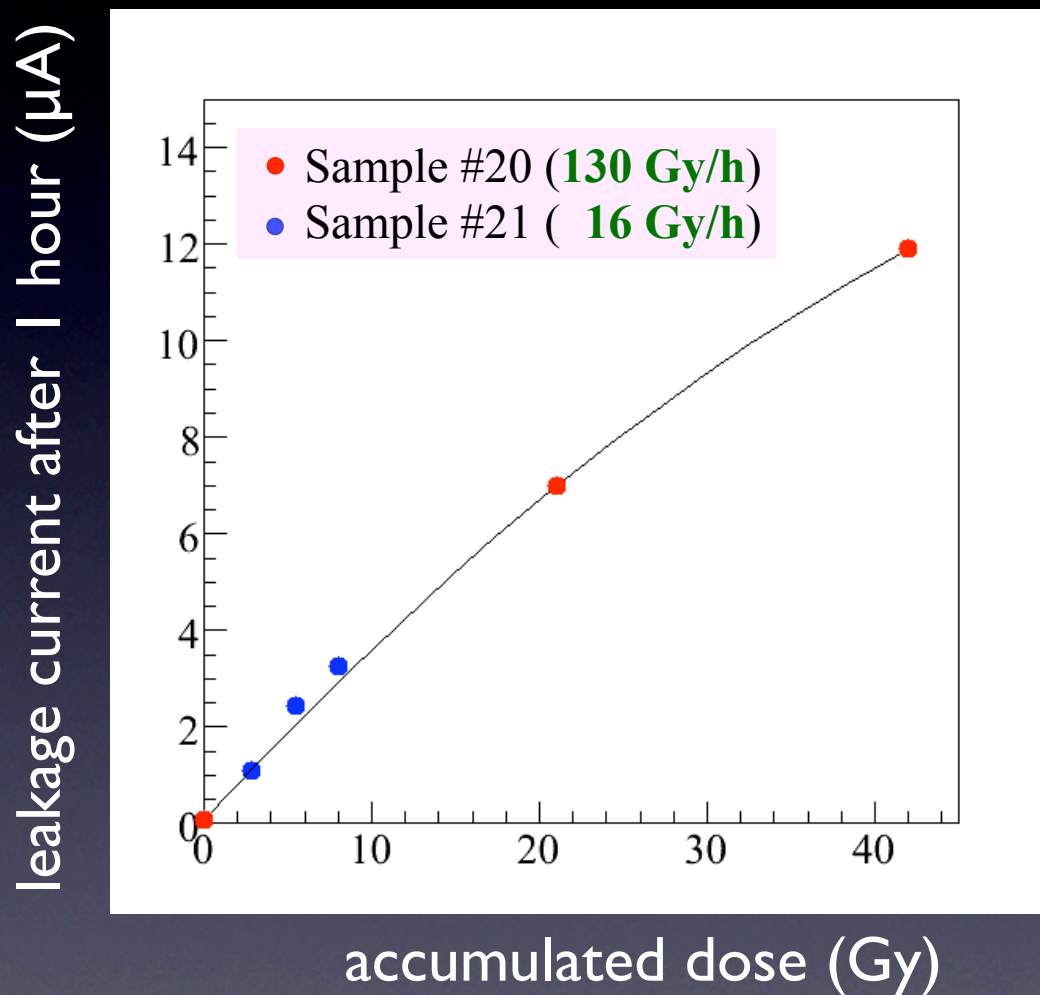


## Crosstalk vs Bias voltage





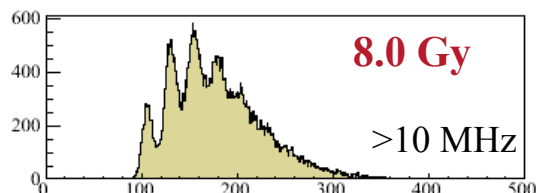
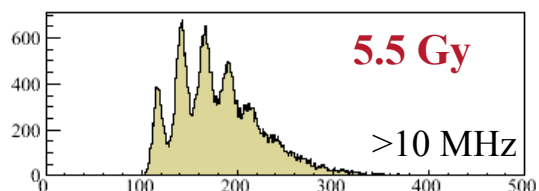
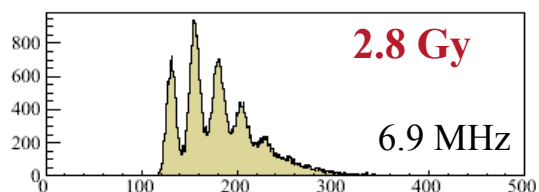
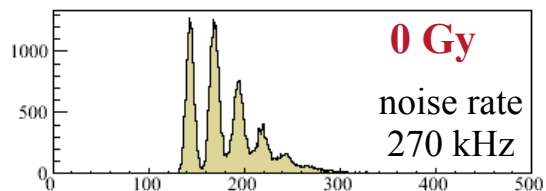
# Proton irradiation



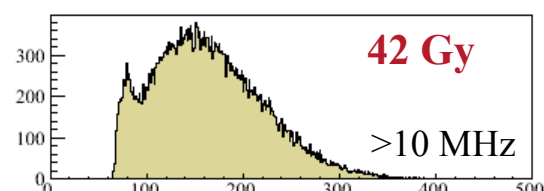
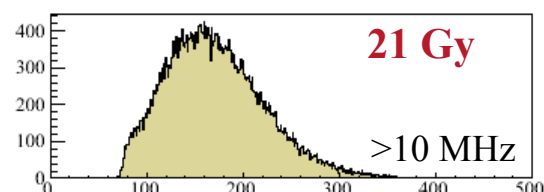
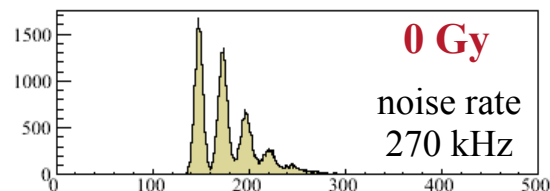
T. Matsumura  
@PD07

# Proton irradiation

Sample #21 (16 Gy/h)



Sample #20 (130 Gy/h)



gate width : 55 ns

Noise-rate measurements were limited due to scaler performance

- Photon-counting capability is lost due to baseline shifts and noise pile-up after 21 Gy irradiation.

T. Matsumura  
@PD07



# Are you interested?

- Many **advantages**:
  - High ( $10^5$ - $10^6$ ) gain with low voltage ( $<100\text{V}$ )
  - High photon detection efficiency
  - Compact and robust
  - Insensitive to magnetic fields
- Although as many **possible drawbacks** *at this moment*:
  - Only small size (typically  $\sim\text{mm}^2$ ) available
  - High dark count rate ( $100\text{kHz}$ - $1\text{MHz}/\text{mm}^2$ )
  - Optical cross-talk and after-pulse





For more information,

- Workshop for photo-detectors, especially focusing on Geiger-mode APDs, was held in June at Kobe.
- Presentations are available on the web.

<http://www-conf.kek.jp/PD07/>

- 'PD08' will be held in fall 2008 in Matsumoto (central Japan).

International Workshop on new photon-detectors  
**PD07**  
June 27-29, 2007 @ Kobe University, JAPAN

Main Topics

- Geiger-mode multi-pixel photon device
- Hybrid-PMT
- APD
- MCP-PMT
- New type of photon-sensors
- Applications of photon-sensors to High Energy Physics, Nuclear Physics, Cosmic-Ray Physics, Astronomy, Cosmology and Medical Science



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Detector Technology Project, IPNS, KEK  
Faculty of Science, Kobe University

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# Final remarks

- MPPC (and other pixelized Geiger-mode APD) has **many attractive features**.
- Still new device:
  - There is much room for improvement/optimization
  - Many intense R&D ongoing over the world
- Direction of development depends on usage
  - Important parameters different for each application



- Hope this talk helps to understand current situation and to design your experiment!

	Gain	Noise	Dynamic range	PDE	Cross-talk	Cost	.....
Number of pixels	—		+	—			
$\Delta V$	+	+		+	+		
Temp	—	+		—	+	?	
Special structure					—?	+?	
Active area		+		+		+?	
.....							

\* Not a complete table but biased by personal view  
 \*\* There may also be correlation...





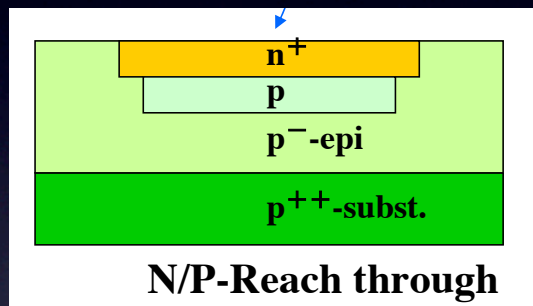
*Thanks!*

*Backup*

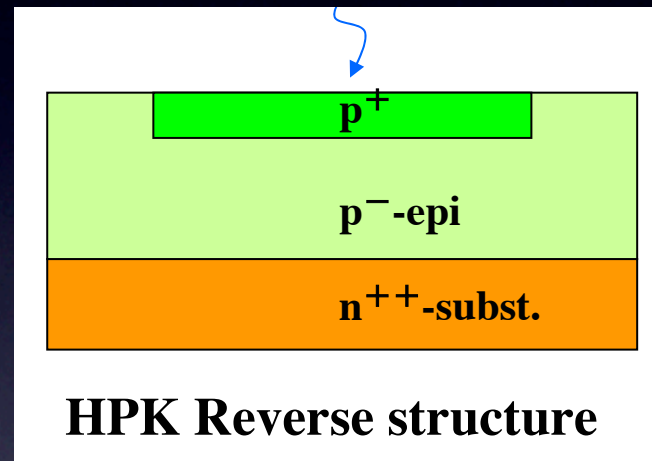


# MPPC structure

Usual device:  
 $n^+$  on  $p/p^-$



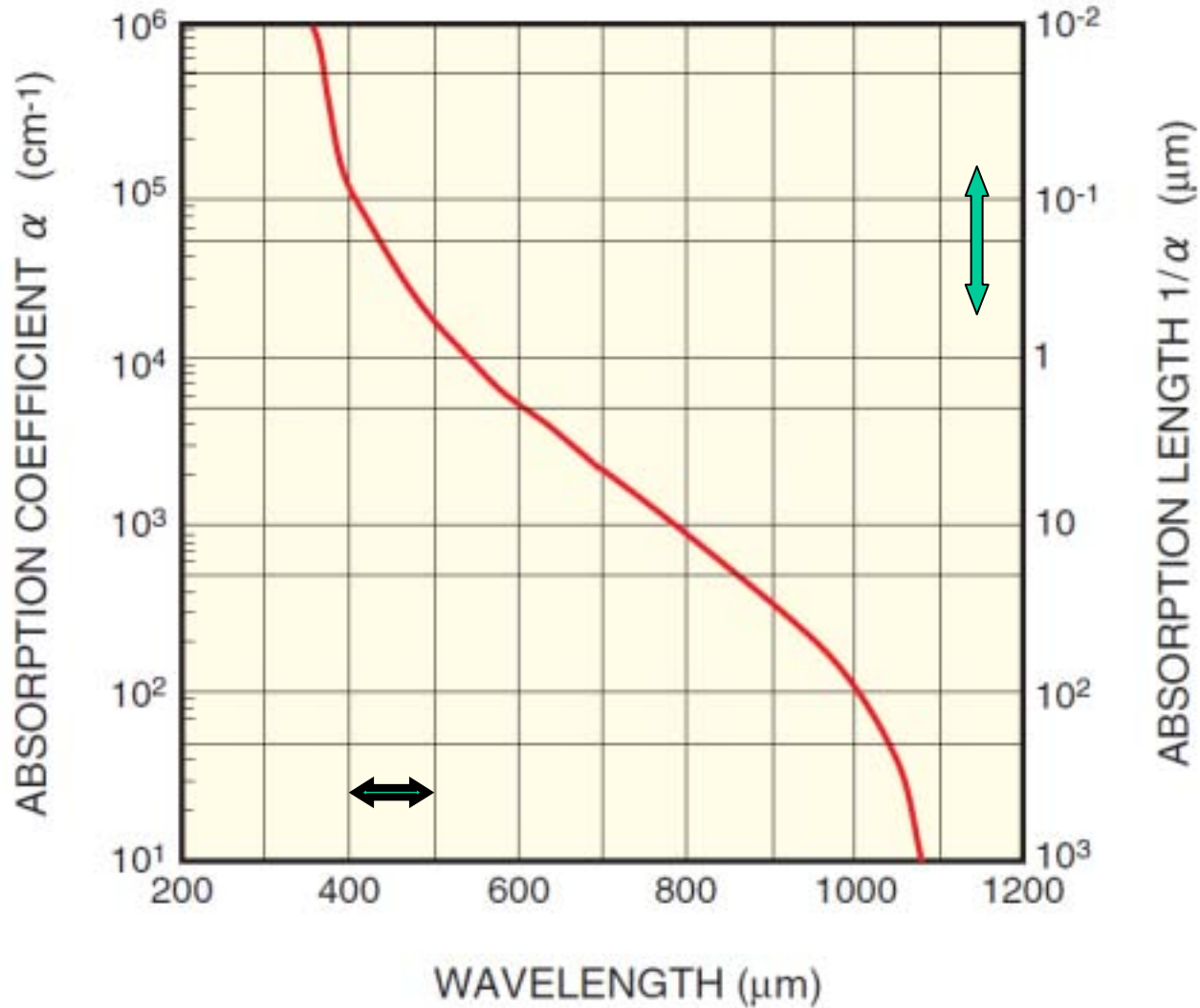
'Reverse structure':  $p^+$  on  $p^-$  epi



K.Yamamoto @ PD07

- Used for CMS-ECAL APD
- Better quantum efficiency to shorter wavelength

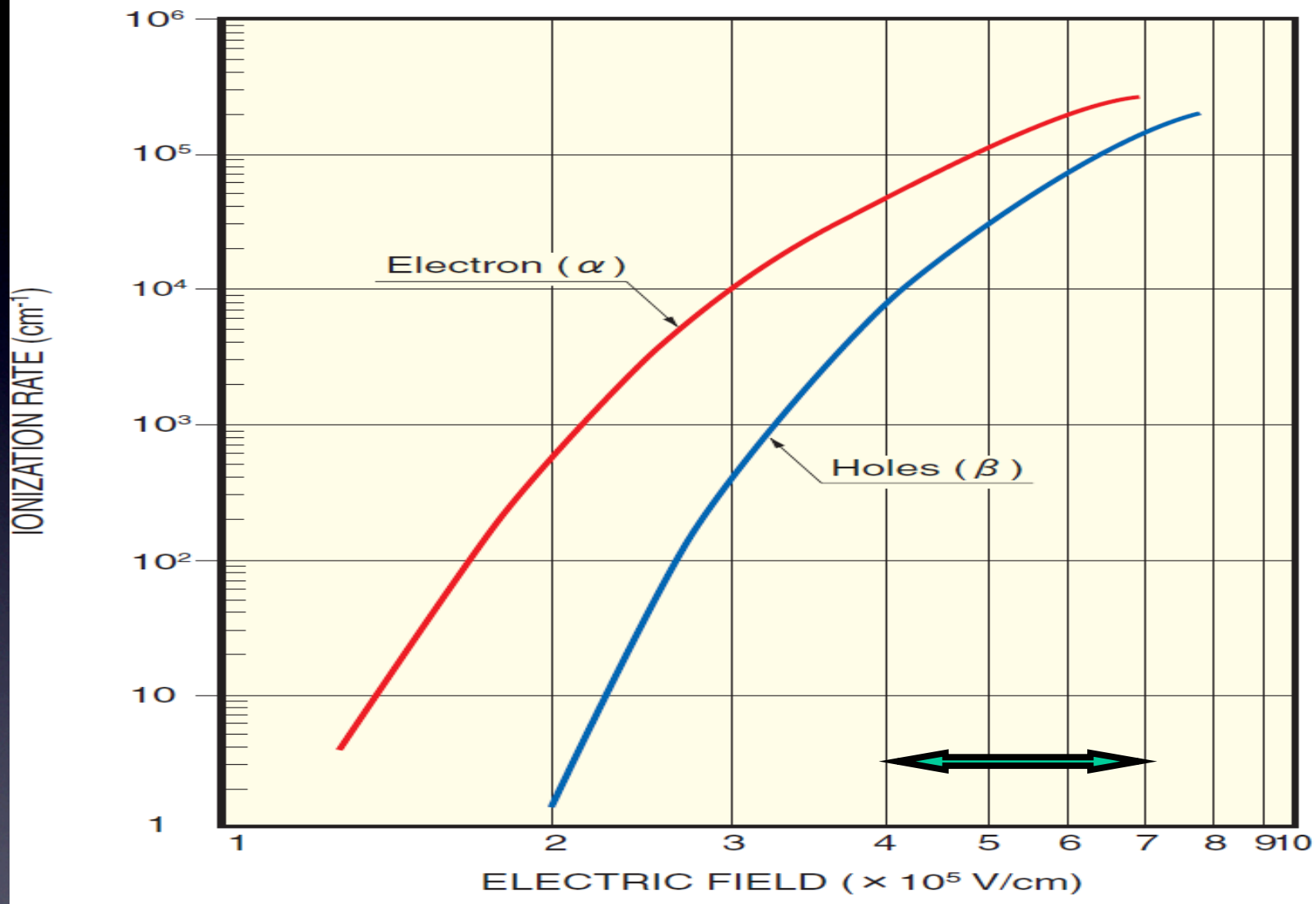
# Photo Absorption coefficient of Silicon



K.Yamamoto @ PD07







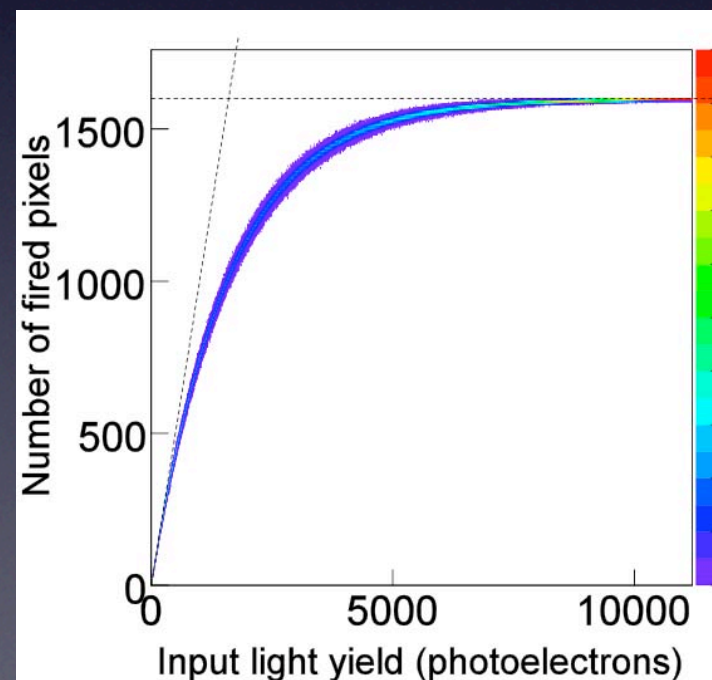
Ionization coefficient for avalanche Multiplication

K. Yamamoto @ PD07



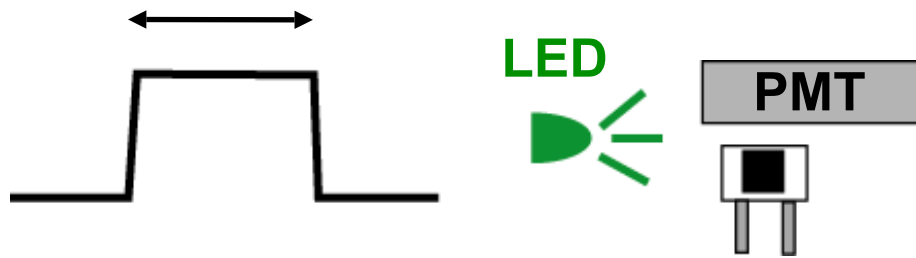
# Dynamic range

- Intrinsically limited by finite number of pixels
  - Affected by cross-talk probability
  - Also depends on time structure of input photons

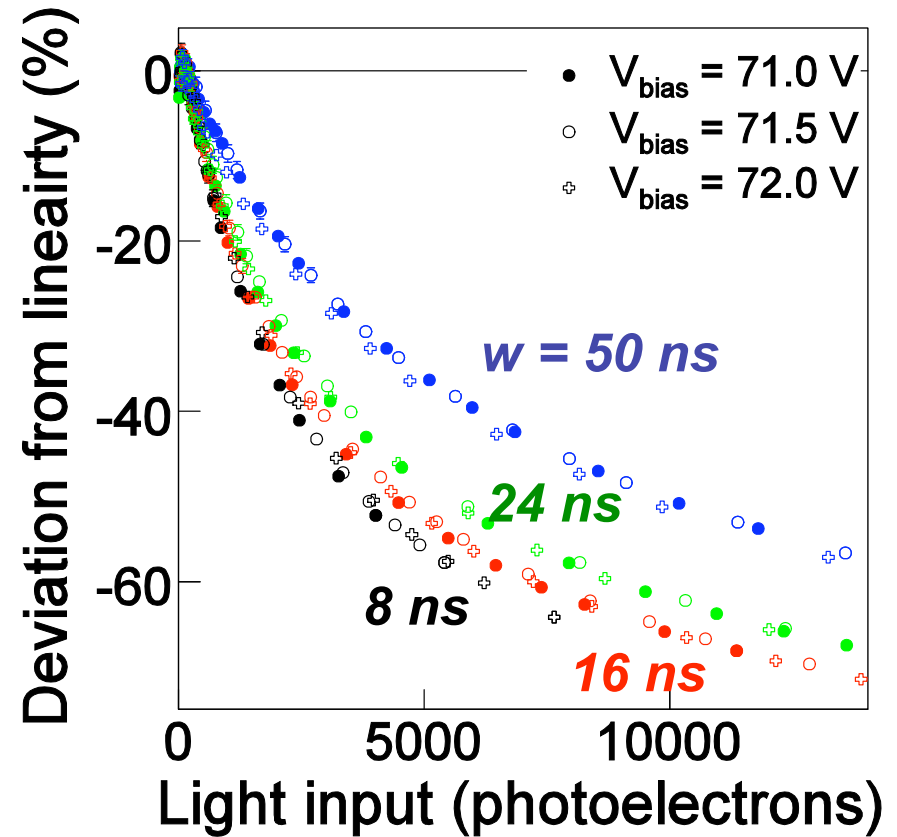
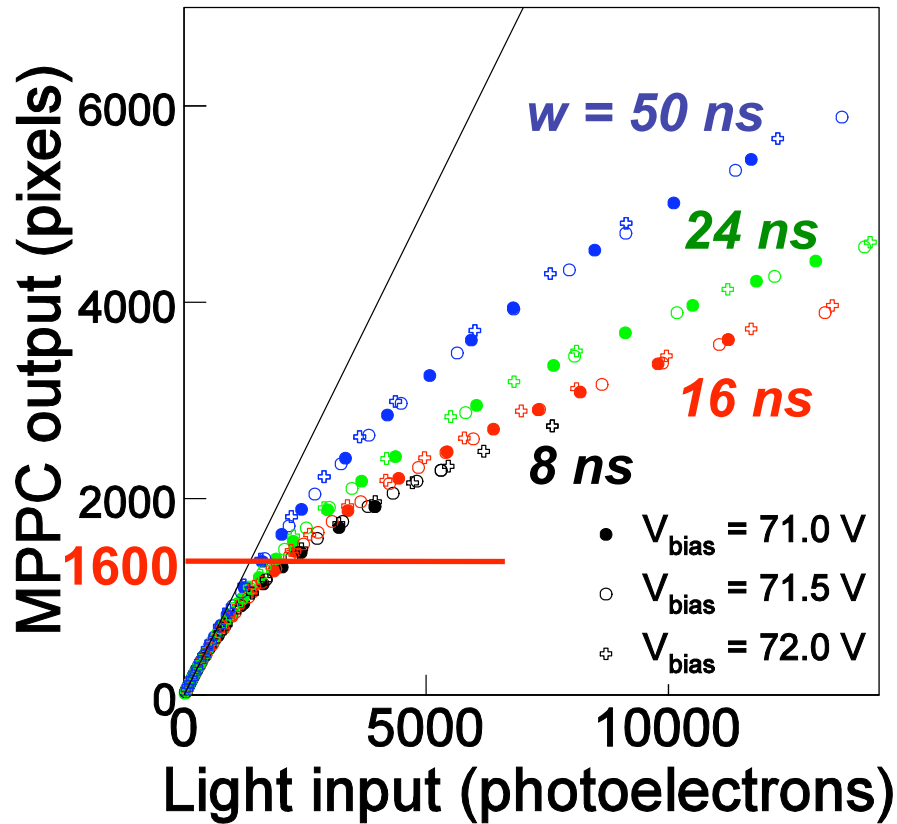




# Response Curve



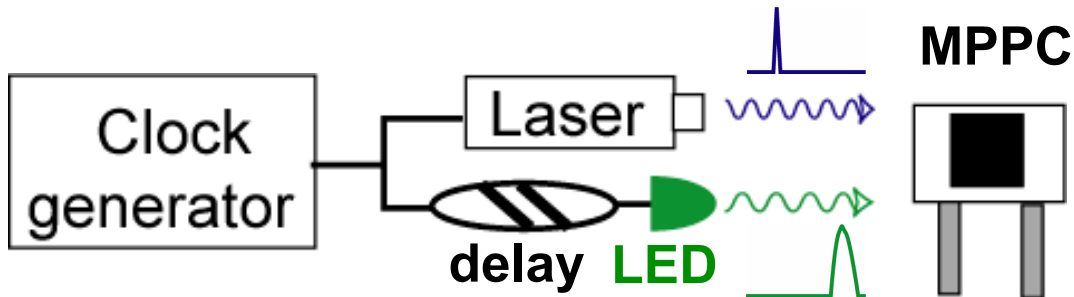
Response curves taken with various width of LED light pulses. (gate width = 100 ns)



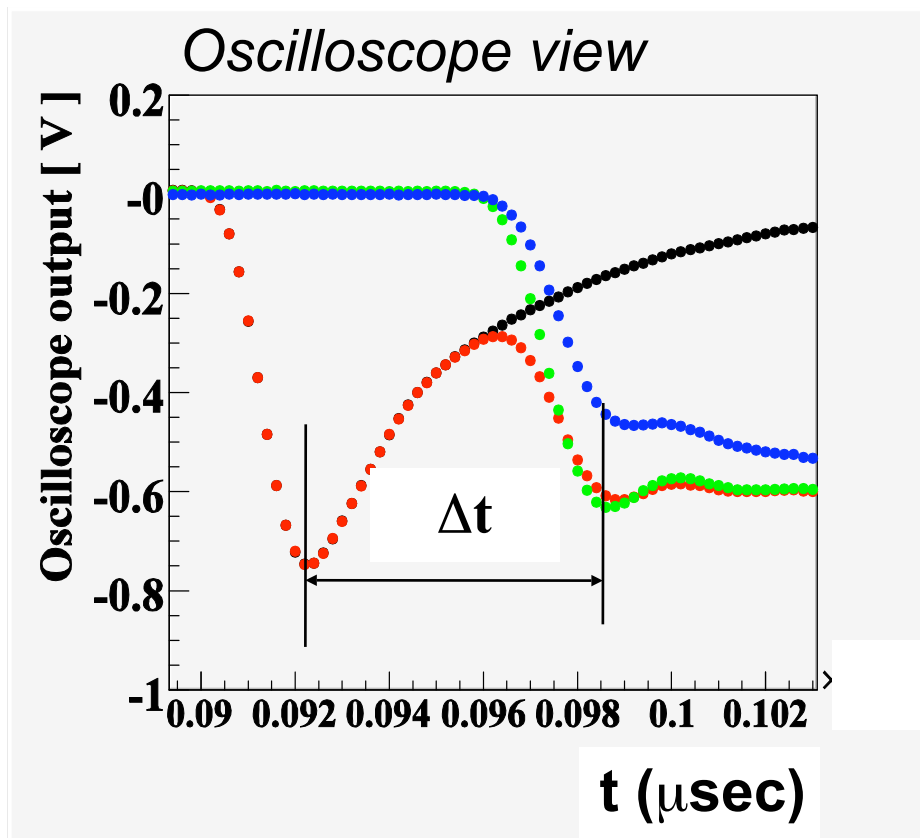
- **Dynamic range is enhanced with longer light pulse,**
- Time structure of the light pulse gives large effects in non-linear region.
- No significant influence with changing bias voltage.
- Knowing time structure of scintillator light signal is crucial  
-> study is ongoing.

# Recovery Time Measurement

S.Uozumi @ PD07



- Inject blight laser pulse (width=52 ps) into the MPPC
- After delay of  $\Delta t$ , inject blight LED light pulse, and measure MPPC output for the LED pulse.
- Compare the MPPC output for the LED pulse with and without the first laser pulse.

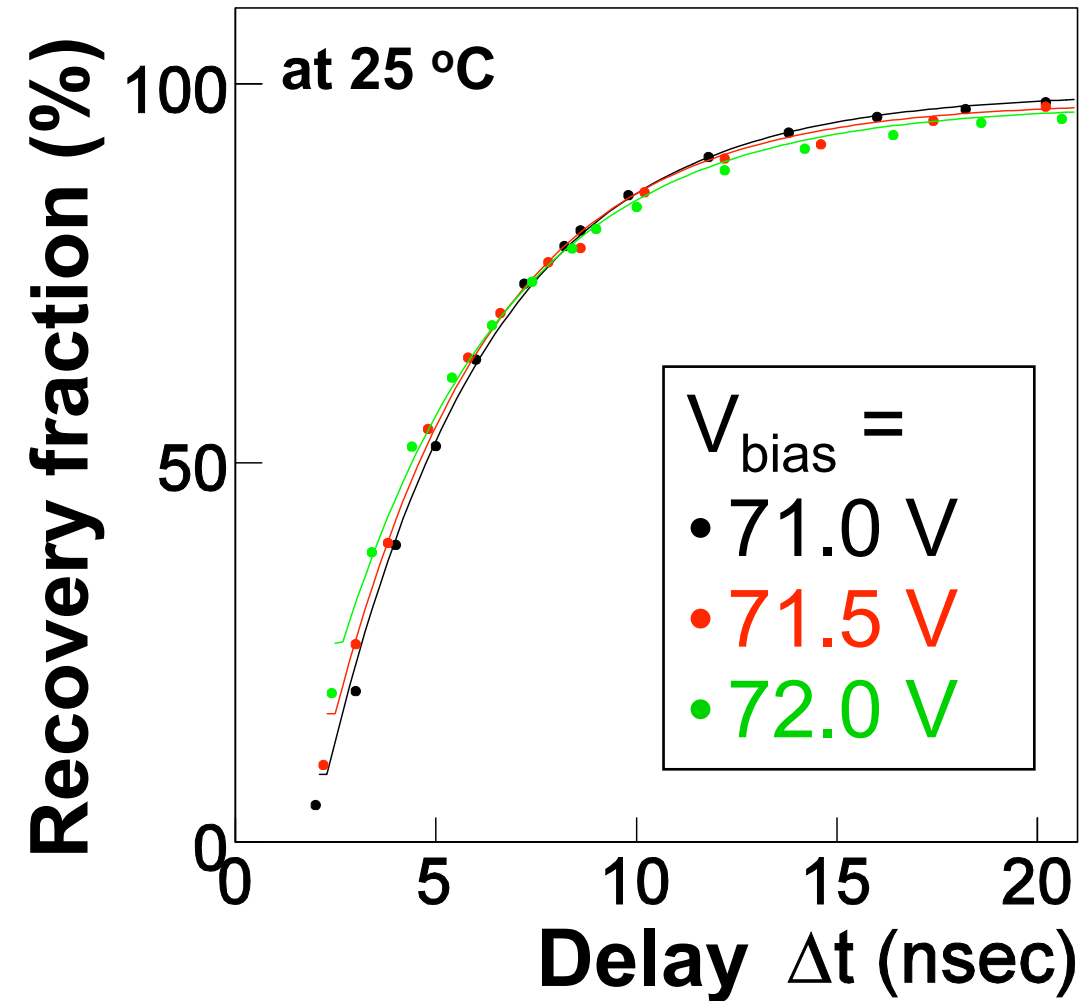


**Black ... MPPC output for Laser pulse**  
**Green ... MPPC output for LED pulse**  
**Red ... Laser + LED**  
**Blue ... (Laser+LED) - Laser**

Ratio of **Blue / Green** shows recovery fraction.



# Recovery Time Result



The curve is fitted by a function

$$f(\Delta t) = A(1 - e^{-(\Delta t - t_D)/\tau})$$

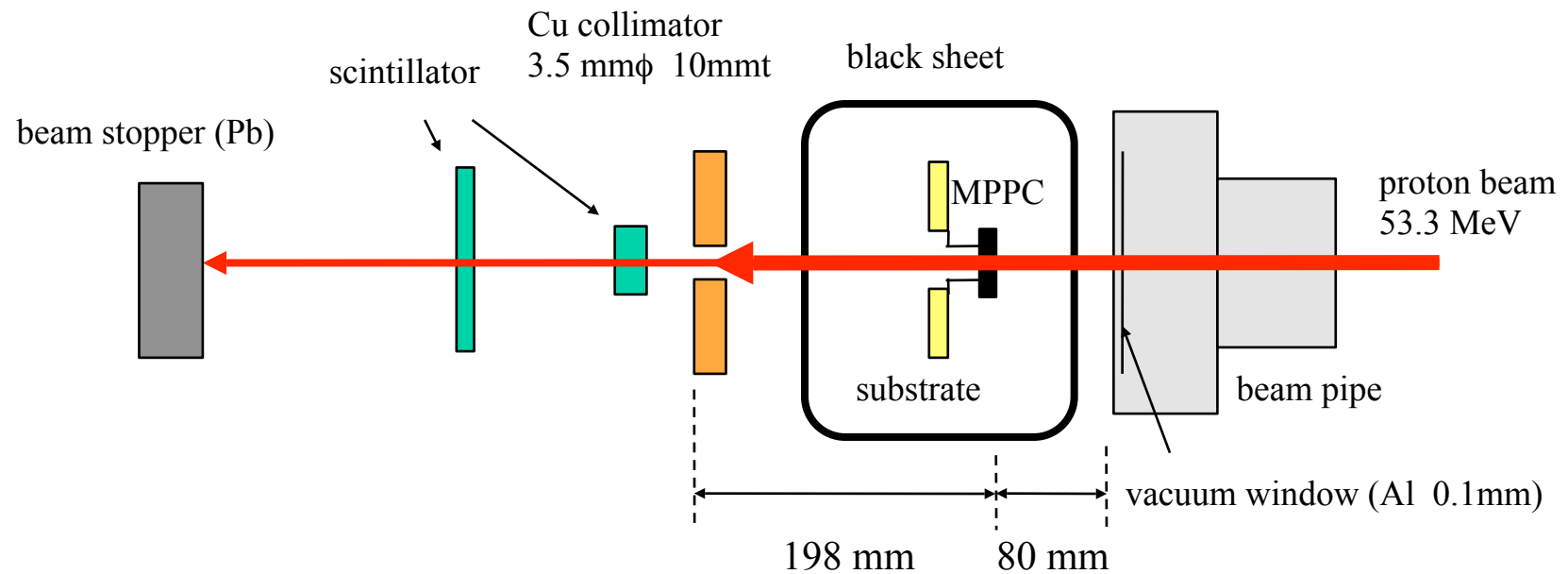
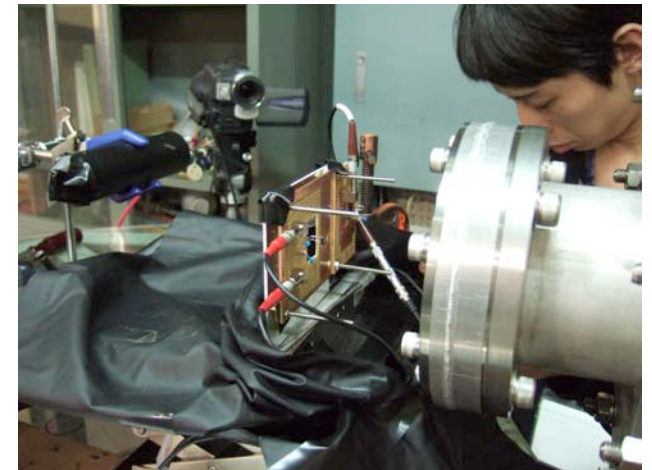
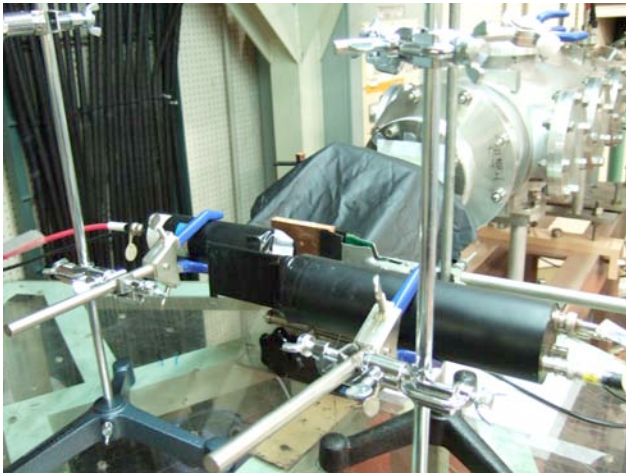
$t_D$  : dead time

$\tau$  : recovery time

$V_{\text{bias}}$ (V)	$\tau$ (nsec)	$t_D$ (nsec)
71.0	$4.1 \pm 0.1$	$1.9 \pm 0.1$
71.5	$4.0 \pm 0.1$	$1.7 \pm 0.1$
72.0	$4.2 \pm 0.1$	$1.3 \pm 0.1$

- Recovery time of the 1600-pixel MPPC  $\sim 4$  ns.
- The shape does not depend on bias voltage.

# Experimental setup

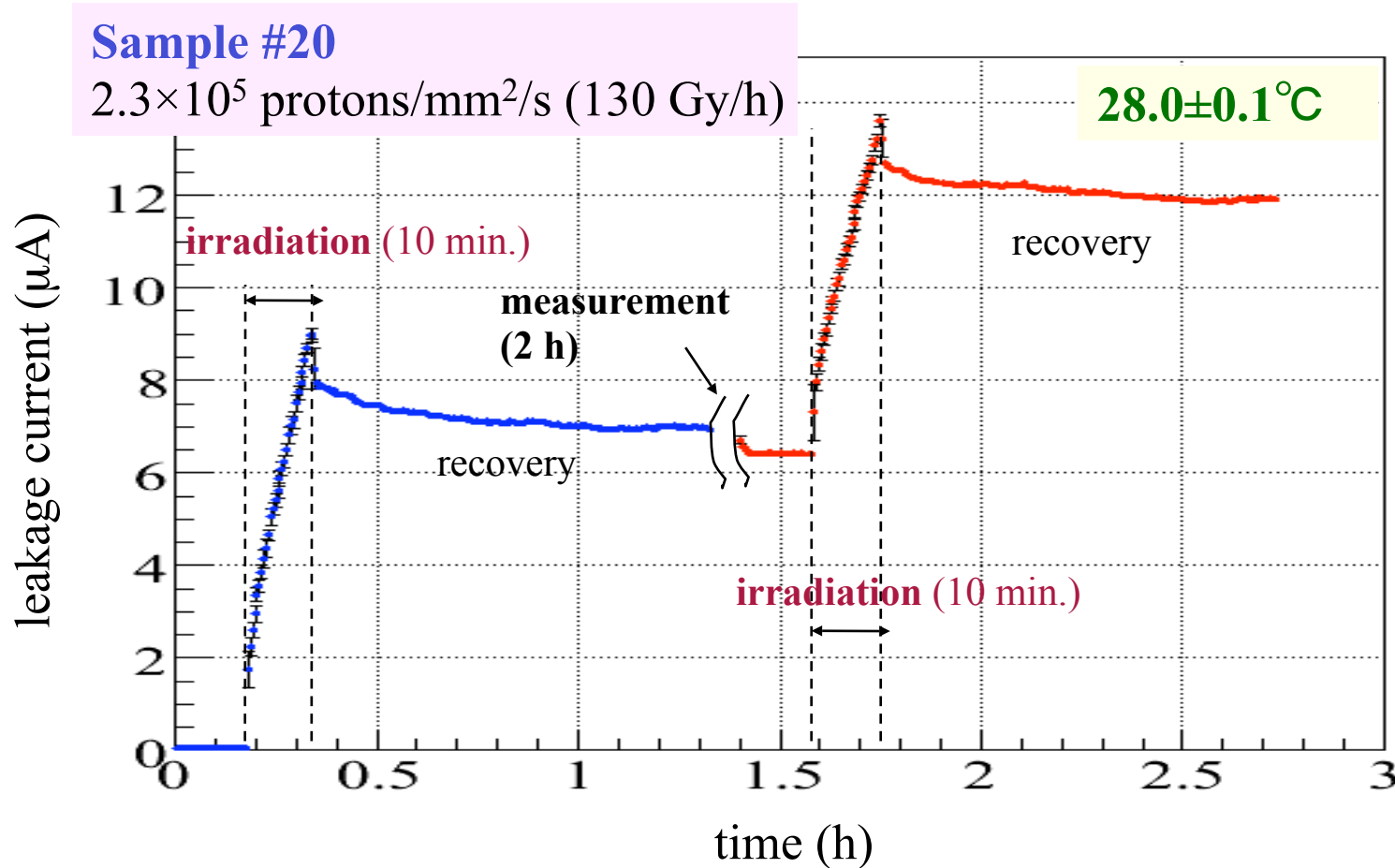


- **Beam intensity** ... monitored with two plastic scintillates



# Variation of the leakage current (higher flux irradiation)

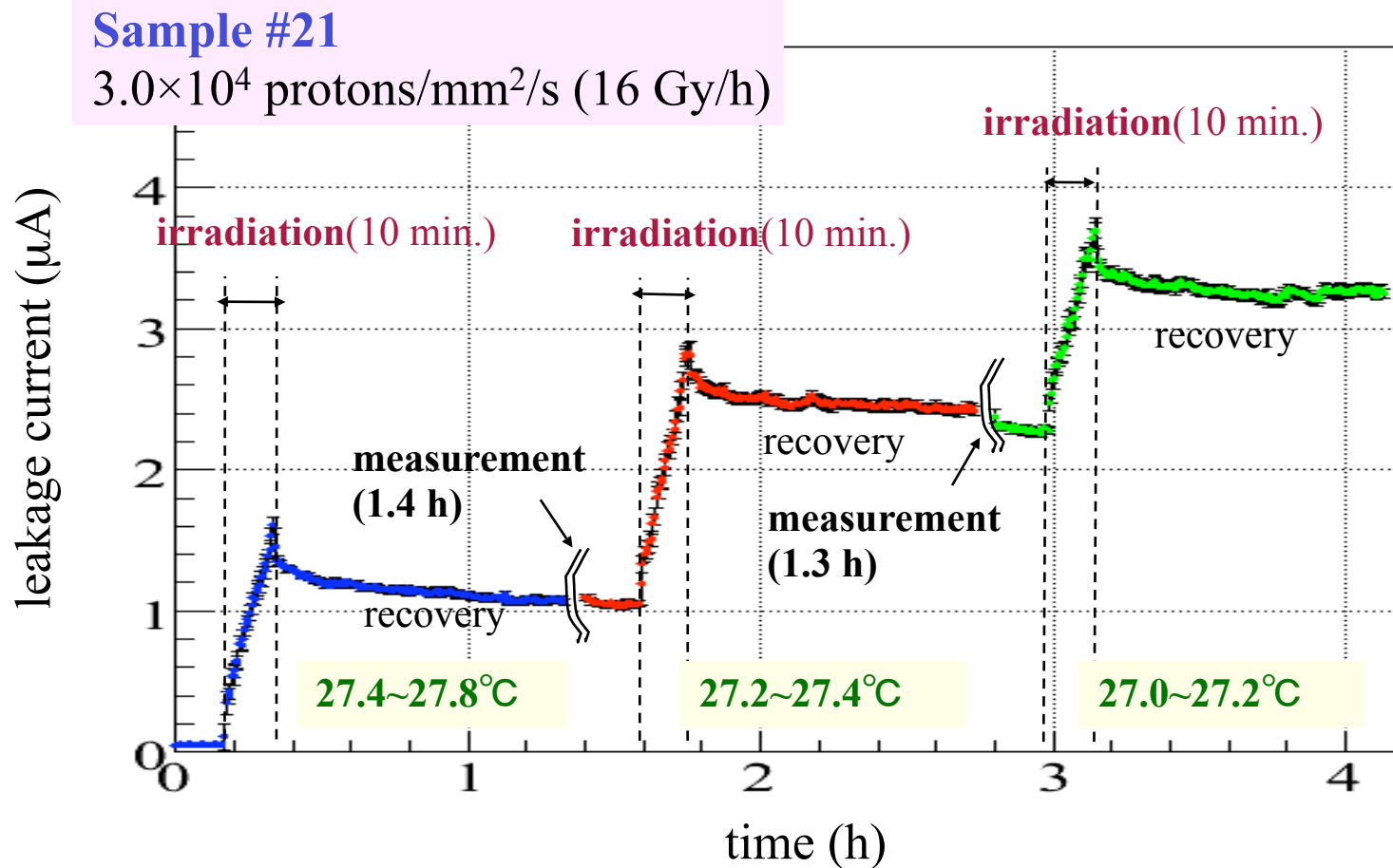
T.Matsumura @ PD07



- The leakage current lineally increases with irradiated doses.
- Annealing effects are seen. But the radiation damage is not completely recovered within a few hour.

# Variation of the leakage current (lower flux irradiation)

T.Matsumura @ PD07



- Similar tendency was observed as the higher-flux irradiation except for increasing rates of the leakage current.